



Report No.: RZA2010-0916



ANSI C63.19 TEST REPORT

| | |
|---------------------|-------------------------------|
| Product Name | cdma2000 Digital Mobile Phone |
| Model | HUAWEI C8600/HUAWEI M860 |
| FCC ID | QISM860 |
| Client | Huawei Technologies Co., Ltd. |

TA Technology (Shanghai) Co., Ltd.



GENERAL SUMMARY

| | | | |
|------------------------------|---|-------------------|--------------------------|
| Product Name | cdma2000 Digital Mobile Phone | Model | HUAWEI C8600/HUAWEI M860 |
| FCC ID | QISM860 | Report No. | RZA2010-0916 |
| Client | Huawei Technologies Co., Ltd. | | |
| Manufacturer | Huawei Technologies Co., Ltd. | | |
| Reference Standard(s) | ANSI C63.19-2007: American National Standard Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids. | | |
| Conclusion | <p>This portable wireless equipment has been measured in all cases requested by the relevant standards.</p> <p>General Judgment: M4 (RF Emission)</p> <div style="text-align: right;">  <p>(Stamp) Date of issue: June 24th, 2010</p> </div> | | |
| Comment | The test result only responds to the measured sample. | | |

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TABLE OF CONTENT

| | |
|---|----|
| 1. General Information | 4 |
| 1.1. Notes of the Test Report..... | 4 |
| 1.2. Testing Laboratory | 4 |
| 1.3. Applicant Information | 5 |
| 1.4. Manufacturer Information..... | 5 |
| 1.5. Information of EUT..... | 6 |
| 1.6. The Ambient Conditions during Test..... | 7 |
| 1.7. The Total M-rating of each tested band | 7 |
| 1.8. Test Date | 7 |
| 2. Test Information | 8 |
| 2.1. Operational Conditions during Test | 8 |
| 2.1.1. General Description of Test Procedures | 8 |
| 2.1.2. CDMA Test Configuration..... | 8 |
| 2.2. HAC RF Measurements System Configuration..... | 9 |
| 2.2.1. HAC Measurement Set-up..... | 9 |
| 2.2.2. Probe System | 10 |
| 2.2.3. Test Arch Phantom & Phone Positioner | 11 |
| 2.3. RF Test Procedures..... | 12 |
| 2.4. System Check..... | 14 |
| 2.5. Probe Modulation Factor..... | 15 |
| 2.6. Conducted Output Power Measurement..... | 17 |
| 3. Test Results | 19 |
| 3.1. ANSI C63.19-2007 Limits | 19 |
| 3.2. Summary Test Results..... | 20 |
| 4. Measurement Uncertainty | 21 |
| 5. Main Test Instruments | 23 |
| ANNEX A: System Check Results..... | 24 |
| ANNEX B: Graph Results..... | 28 |
| ANNEX C: E-Probe Calibration Certificate | 46 |
| ANNEX D: H-Probe Calibration Certificate..... | 56 |
| ANNEX E: CD835V3 Dipole Calibration Certificate (SN:1149)..... | 66 |
| ANNEX F: CD1880V3 Dipole Calibration Certificate (SN:1135)..... | 72 |
| ANNEX G: DAE4 Calibration Certificate..... | 78 |
| ANNEX H: The EUT Appearances and Test Configuration..... | 83 |

1. General Information

1.1. Notes of the Test Report

TA Technology (Shanghai) Co., Ltd. guarantees the reliability of the data presented in this test report, which is the results of measurements and tests performed for the items under test on the date and under the conditions stated in this test report and is based on the knowledge and technical facilities available at TA Technology (Shanghai) Co., Ltd. at the time of execution of the test.

TA Technology (Shanghai) Co., Ltd. is liable to the client for the maintenance by its personnel of the confidentiality of all information related to the items under test and the results of the test. This report only refers to the item that has undergone the test.

This report standalone dose not constitute or imply by its own an approval of the product by the certification Bodies or competent Authorities. This report cannot be used partially or in full for publicity and/or promotional purposes without previous written approval of **TA Technology (Shanghai) Co., Ltd.** and the Accreditation Bodies, if it applies.

1.2. Testing Laboratory

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1.4. Manufacturer Information

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TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA2010-0916

Page 6 of 83

1.5. Information of EUT

General Information

| | | | |
|--|---|---|----------------------------------|
| Device Type: | Portable Device | | |
| Product Name: | cdma2000 Digital Mobile Phone | | |
| SN: | 2X2AA11051900058 | | |
| Antenna Type: | Internal Antenna | | |
| Device Operating Configurations: | | | |
| Operating Mode(s): | CDMA Cellular (tested) | | |
| | CDMA PCS (tested) | | |
| | CDMA AWS (tested) | | |
| Test Modulation: | QPSK | | |
| Operating Frequency Range(s): | Band | Tx (MHz) | Rx (MHz) |
| | CDMA Cellular | 824.7 ~ 848.31 | 869.7 ~ 893.31 |
| | CDMA PCS | 1851.25 ~ 1908.75 | 1931.25 ~ 1988.75 |
| | CDMA AWS | 1711.25 ~ 1752.5 | 2111.25 ~ 2152.5 |
| Test Channel: (Low - Middle - High) | 1013 - 384 - 777 25 - 600 - 1175 25 - 450 - 850 | (CDMA Cellular) (CDMA PCS) (CDMA AWS) | (tested) (tested) (tested) |
| Power Class: | CDMA Cellular: Tested with Power Control All up bits | | |
| | CDMA PCS: Tested with Power Control All up bits | | |
| | CDMA AWS: Tested with Power Control All up bits | | |
| Hardware Version: | HC1M860M | | |
| Software Version: | M860V100R001C153B225 | | |

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA2010-0916

Page 7 of 83

Auxiliary Equipment Details

AE1:Battery

Model: HB4F1
Manufacturer: Huawei Technologies Co., Ltd.
SN: SCC9A07HI4124145

AE2:Travel Adapter

Model: HW-050100U1W
Manufacturer: Huawei Technologies Co., Ltd.
SN: HKAA50924234

Equipment Under Test (EUT) is a model of cdma2000 Digital Mobile Phone with internal antenna. The detail about Mobile phone, Lithium Battery and AC/DC Adapter is in chapter 1.5 in this report. SAR is tested for CDMA Cellular, CDMA PCS and CDMA AWS.

The sample under test was selected by the Client.

Components list please refer to documents of the manufacturer.

1.6. The Ambient Conditions during Test

| | |
|---|---------------------------|
| Temperature | Min. = 18°C, Max. = 28 °C |
| Relative humidity | Min. = 0%, Max. = 80% |
| Ground system resistance | < 0.5 Ω |
| Ambient noise is checked and found very low and in compliance with requirement of standards. Reflection of surrounding objects is minimized and in compliance with requirement of standards. | |

1.7. The Total M-rating of each tested band

| Band | Rating |
|---------------|-----------|
| CDMA Cellular | M4 |
| CDMA PCS | M4 |
| CDMA AWS | M4 |

1.8. Test Date

The test is performed on June 22, 2010.

2. Test Information

2.1. Operational Conditions during Test

2.1.1. General Description of Test Procedures

The phone was tested in all normal configurations for the ear use. The EUT is mounted in the device holder equivalent as for classic dosimeter measurements. The acoustic output of the EUT shall coincide with the center point of the area formed by the dielectric wire and the middle bar of the arch's top frame. The EUT shall be moved vertically upwards until it touches the frame. The fine adjustment is possible by sliding the complete. EUT holder on the yellow base plate of the Test Arch phantom. These test configurations are tested at the high, middle and low frequency channels of each applicable operating mode; for example, GSM, WCDMA (UMTS), CDMA and TDMA.

2.1.2. CDMA Test Configuration

A communication link is set up with a System Simulator (SS) by air link, and a call is established. The Absolute Radio Frequency Channel Number (ARFCN) are allocated to 1013, 384 and 777 respectively in the case of CDMA Cellular, allocated to 25, 600 and 1175 respectively in the case of CDMA PCS, allocated to 25, 450 and 850 respectively in the case of CDMA AWS, The EUT is commanded to operate at maximum transmitting power.

Test Parameter setup for maximum RF output power according to section 4.4.5 of 3GPP2.

| Parameter | Units | Value |
|------------------|-------------|-------|
| I or | dBm/1.23MHz | -104 |
| PilotE c /I or | dB | -7 |
| TrafficE c /I or | dB | -7.4 |

2.2. HAC RF Measurements System Configuration

2.2.1. HAC Measurement Set-up

These measurements are performed using the DASY4 automated dosimetric assessment system. It is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland. It consists of high precision robotics system (Stäubli), robot controller, Intel Core2 computer, near-field probe, probe alignment sensor. The robot is a six-axis industrial robot performing precise movements. Cell controller systems contain the power supply, robot controller, teach pendant (Joystick) and remote control, and are used to drive the robot motors. The Stäubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit performs the signal amplification; signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.

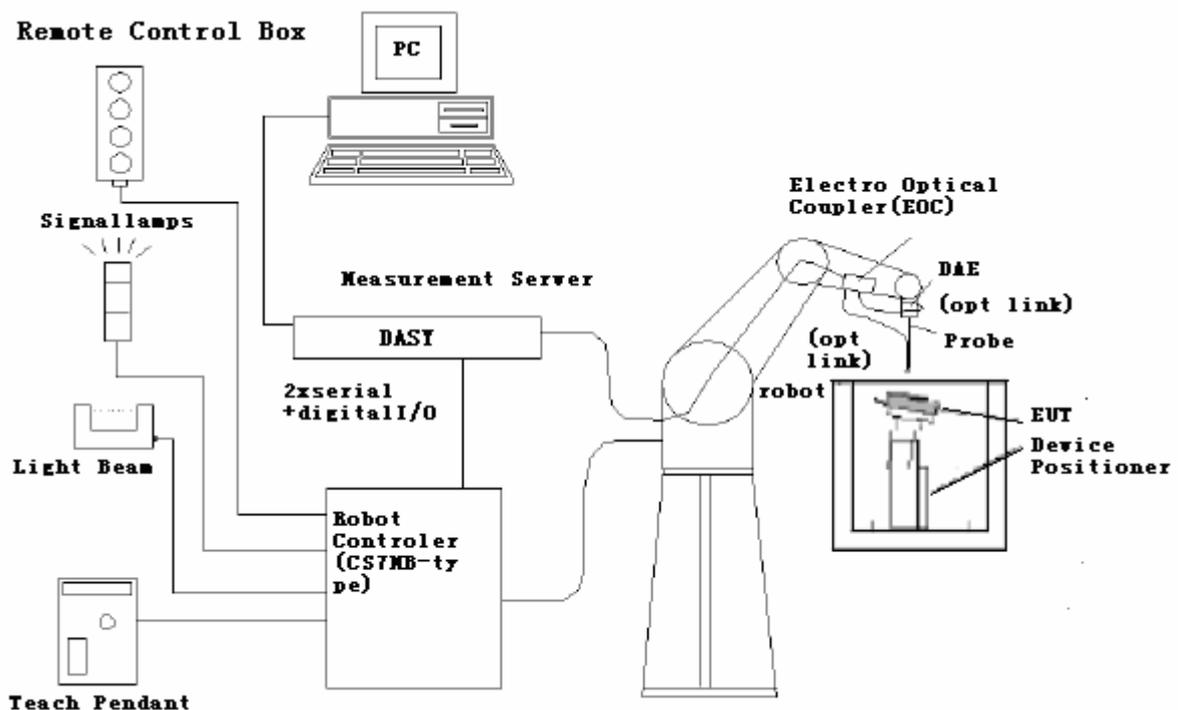


Figure 1 HAC Test Measurement Set-up

The DAE4 consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.

2.2.2. Probe System

The HAC measurements were conducted with the E-Field Probe ER3DV6 and the H-Field Probe H3DV6 (manufactured by SPEAG), designed in the classical triangular configuration and optimized for dosimetric evaluation.

E-Field Probe Description

| | |
|---------------|---|
| Construction | One dipole parallel, two dipoles normal to probe axis Built-in shielding against static charges PEEK enclosure material |
| Calibration | In air from 100 MHz to 3.0 GHz (absolute accuracy $\pm 6.0\%$, $k=2$) |
| Frequency | 40 MHz to > 6 GHz (can be extended to < 20 MHz) Linearity: ± 0.2 dB (100 MHz to 3 GHz) |
| Directivity | ± 0.2 dB in air (rotation around probe axis) ± 0.4 dB in air (rotation normal to probe axis) |
| Dynamic Range | 2 V/m to > 1000 V/m; Linearity: ± 0.2 dB |
| Dimensions | Overall length: 330 mm (Tip: 16 mm) Tip diameter: 8 mm (Body: 12 mm) Distance from probe tip to dipole centers: 2.5 mm |
| Application | General near-field measurements up to 6 GHz Field component measurements Fast automatic scanning in phantoms |



Figure 2 ER3DV6 E-field Probe

H-Field Probe Description

| | |
|----------------------|---|
| Construction | Three concentric loop sensors with 3.8 mm loop diameters Resistively loaded detector diodes for linear response Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., glycolether) |
| Frequency | 200 MHz to 3 GHz (absolute accuracy $\pm 6.0\%$, $k=2$); Output linearized |
| Directivity | ± 0.2 dB (spherical isotropy error) |
| Dynamic Range | 10 mA/m to 2 A/m at 1 GHz |
| E-Field Interference | < 10% at 3 GHz (for plane wave) |
| Dimensions | Overall length: 330 mm (Tip: 40 mm) Tip diameter: 6 mm (Body: 12 mm) Distance from probe tip to dipole centers: 3 mm |



Figure 3 H3DV6 H-field Probe

Application General magnetic near-field measurements up to 3
 GHz (in air or liquids)
 Field component measurements
 Surface current measurements
 Low interaction with the measured field

2.2.3. Test Arch Phantom & Phone Positioner

The Test Arch phantom should be positioned horizontally on a stable surface. Reference markings on the Phantom allow the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot. It enables easy and well defined positioning of the phone and validation dipoles as well as simple teaching of the robot (Dimensions: 370 x 370 x 370 mm).

The Device reference point is set for the EUT at 6.3 mm, the Grid reference point is on the upper surface at the origin of the coordinates, and the “user point \Height Check 0.5 mm” is 0.5mm above the center, allowing verification of the gap of 0.5mm while the probe is positioned there.

The Phone Positioner supports accurate and reliable positioning of any phone with effect on near field $<\pm 0.5$ dB.

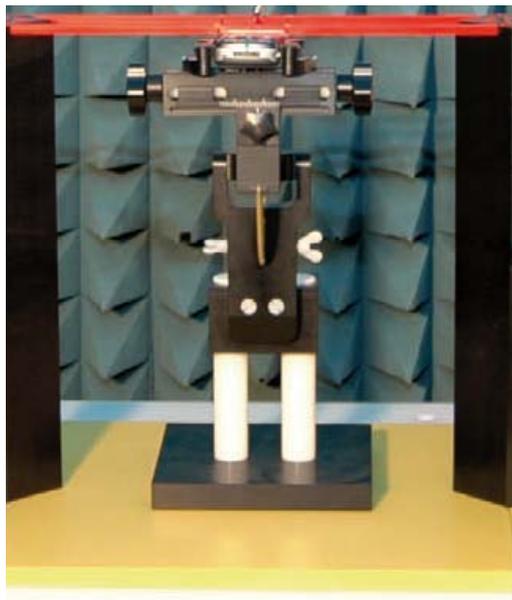


Figure 4 HAC Phantom & Device Holder

2.3. RF Test Procedures

The evaluation was performed with the following procedure:

1. Confirm proper operation of the field probe, probe measurement system and other instrumentation and the positioning system.
2. Position the WD in its intended test position. The gauge block can simplify this positioning. Note that a separate E-field and H-field gauge block will be needed if the center of the probe sensor elements is at different distances from the tip of the probe.
3. Configure the WD normal operation for maximum rated RF output power, at the desired channel and other operating parameters (e.g., test mode), as intended for the test.
4. The center sub-grid shall center on the center of the axial measurement point or the acoustic output, as appropriate. Locate the field probe at the initial test position in the 50 mm by 50 mm grid, which is contained in the measurement plane. If the field alignment method is used, align the probe for maximum field reception.
5. Record the reading.
6. Scan the entire 50 mm by 50 mm region in equally spaced increments and record the reading at each measurement point. The grid is 5 cm by 5 cm area that is divided into 9 evenly sized blocks or sub-grids. The distance between measurement points shall be sufficient to assure the identification of the maximum reading.
7. Identify the five contiguous sub-grids around the center sub-grid with the lowest maximum field strength readings. Thus the six areas to be used to determine the WD's highest emissions are identified and outlined for the final manual scan. Please note that a maximum of five blocks can be excluded for both E-field and H-field measurements for the WD output being measured. Stated another way, the center sub-grid and three others must be common to both the E-field and H-field measurements.
8. Identify the maximum field reading within the non-excluded sub-grids identified in Step 7.
9. Convert the maximum field strength reading identified in Step 8 to V/m or A/m, as appropriate. For probes which require a probe modulation factor, this conversion shall be done using the appropriate probe modulation factor and the calibration.
10. Repeat Step 1 through Step 10 for both the E-field and H-field measurements.
11. Compare this reading to the categories in ANSI C63.19 Clause 7 and record the resulting category. The lowest category number listed in 7.2, Table 7.4, or Table 7.5 obtained in Step 10 for either E- or H-field determines the M category for the audio coupling mode assessment. Record the WD category rating.



Figure 5 WD reference and plane for RF emission measurements

2.4. System Check

Validation Procedure

Place a dipole antenna meeting the requirements given in ANSI C63.19 D.5 in the position normally occupied by the WD. The dipole antenna serves as a known source for an electrical and magnetic output. Position the E-field and H-field probes so that:

The probes and their cables are parallel to the coaxial feed of the dipole antenna.

The probe cables and the coaxial feed of the dipole antenna approach the measurement area from opposite directions.

The center point of the probe element(s) are 10 mm from the closest surface of the dipole elements. Validation was performed to verify that measured E-field and H-field values are within +/-25% from the target reference values provided by the manufacturer. "Values within +/-25% are acceptable. Of which 12% is deviation and 13% is measurement uncertainty."

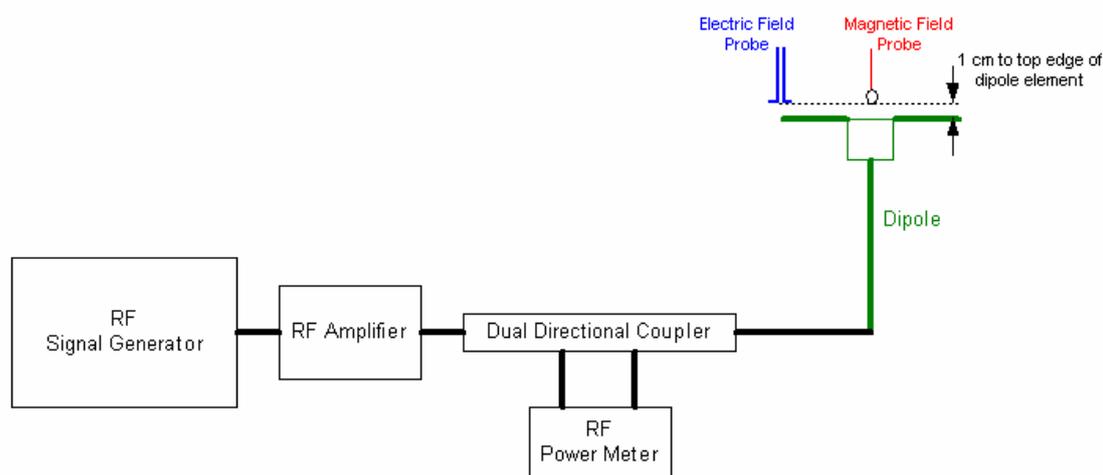


Figure 6 Dipole Validation Setup

Dipole Measurement Summary

| E-Field Scan | | | | | | |
|--------------|-----------------|------------------|----------------------------------|--------------------------------|----------------------------|---------------|
| Mode | Frequency (MHz) | Input Power (mW) | Measured ¹ Value(V/m) | Target ² Value(V/m) | Deviation ³ (%) | Test Date |
| CW | 835 | 100 | 149.2 | 170.7 | 12.60 | June 22, 2010 |
| CW | 1880 | 100 | 131.4 | 142.9 | 8.05 | June 22, 2010 |
| F-Field Scan | | | | | | |
| Mode | Frequency (MHz) | Input Power (mW) | Measured Value(A/m) | Target Value(A/m) | Deviation (%) | Test Date |
| CW | 835 | 100 | 0.443 | 0.465 | 4.73 | June 22, 2010 |
| CW | 1880 | 100 | 0.449 | 0.475 | 5.47 | June 22, 2010 |

Notes: 1. please refer to the attachment for detailed measurement data and plot.

2. Target value is provided by SPEAD in the calibration certificate of specific dipoles.

3. Deviation (%) = 100 * (Target value minus Measured value) divided by Target value.

2.5. Probe Modulation Factor

The Probe Modulation Factor (PMF) is defined as the ratio of the field readings for a CW and a modulated signal with the equivalent Field Envelope Peak as defined in ANSI C63.19 (Chapter C.3.1). Calibration shall be made of the modulation response of the probe and its instrumentation chain. This Calibration shall be performed with the field probe, attached to the instrumentation that is to be used with it during the measurement. The response of the probe system to a CW field at the frequency(s) of interest is compared to its response to a modulated signal with equal peak amplitude. The field level of the test signals shall be more than 10dB above the ambient level and the noise floor of the instrumentation being used. The ratio of the CW reading to that taken with a modulated field shall be applied to the readings taken of modulated fields of the specified type.

Modulation Factor Test Procedure

This may be done using the following procedure:

1. Fix the field probe in a set location relative to a field generating device, such as the reference dipole antenna.
2. Illuminate the probe using the wireless device connected to the reference dipole with a test signal at the intended measurement frequency, Ensure there is sufficient field coupling between the probe and the antenna so the resulting reading is greater than 10 dB above the probe system noise floor but within the systems operating range.
3. Record the amplitude applied to the antenna during transmission and the field strength measured by the E-field probe located near the tip of the dipole antenna
4. Replace the wireless device with an RF signal generator producing an unmodulated CW signal and set to the wireless device operating frequency.
5. Set the amplitude of the unmodulated signal to equal that recorded from the wireless device.
6. Record the reading of the probe measurement system of the unmodulated signal.
7. The ratio, in linear units, of the probe reading in Step 6 to the reading in Step 3 is the E-field modulation factor. $PMF_E = E_{CW} / E_{mod}$ ($PMF_H = H_{CW} / H_{mod}$)
8. Repeat the previous steps using the H-field probe, except locate the probe at the center of the dipole.

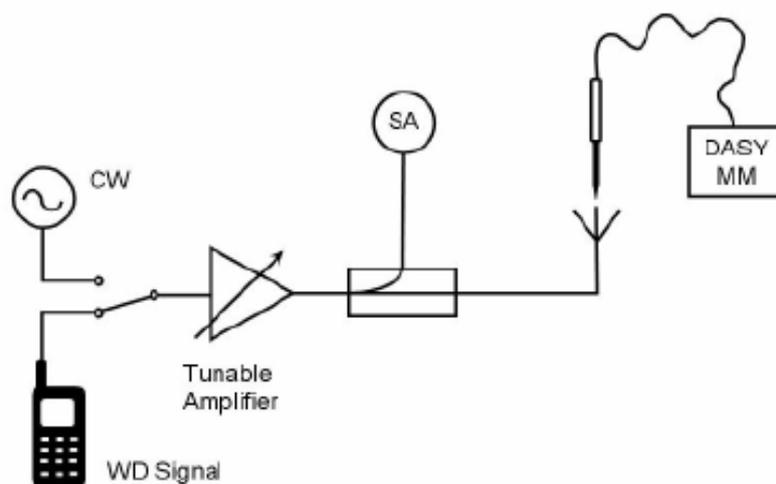


Figure Figure 7 Probe Modulation Factor Test Setup

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA2010-0916

Page 16 of 83

PMF

| Band | E-Field Probe Modulation Factor | H-Field Probe Modulation Factor |
|---------------|--|--|
| CDMA Cellular | 1.0 | 1.0 |
| CDMA PCS | 1.0 | 1.0 |
| CDMA AWS | 1.0 | 1.0 |

TA Technology (Shanghai) Co., Ltd.
Test Report

2.6. Conducted Output Power Measurement

Summary

The DUT is tested using an E5515C communications tester as controller unit to set test channels and maximum output power to the DUT, as well as for measuring the conducted power. Conducted output power was measured using an integrated RF connector and attached RF cable. This result contains conducted output power for the EUT.

Conducted Power Results

| CDMA Cellular (RC3) | Conducted Power(dBm) | | |
|---------------------------------------|-----------------------------|-------------|--------------|
| | Channel 1013 | Channel 384 | Channel 777 |
| Before test | 23.92 | 23.44 | 23.60 |
| After test | 23.91 | 23.46 | 23.62 |
| CDMA Cellular (RC1) | Conducted Power(dBm) | | |
| | Channel 1013 | Channel 384 | Channel 777 |
| Before test | 23.93 | 23.38 | 23.56 |
| After test | 23.93 | 23.41 | 23.55 |
| CDMA Cellular EVDO (Rev.0) | Conducted Power(dBm) | | |
| | Channel 1013 | Channel 384 | Channel 777 |
| Before test | 23.63 | 23.23 | 23.51 |
| After test | 23.61 | 23.20 | 23.48 |
| CDMA Cellular EVDO (Rev.A) | Conducted Power(dBm) | | |
| | Channel 1013 | Channel 384 | Channel 777 |
| Before test | 23.58 | 23.23 | 23.53 |
| After test | 23.62 | 23.20 | 23.55 |
| CDMA PCS (RC3) | Conducted Power(dBm) | | |
| | Channel 25 | Channel 600 | Channel 1175 |
| Before test | 25.12 | 23.86 | 24.20 |
| After test | 25.13 | 23.84 | 24.24 |
| CDMA PCS (RC1) | Conducted Power(dBm) | | |
| | Channel 25 | Channel 600 | Channel 1175 |
| Before test | 25.10 | 23.80 | 24.21 |
| After test | 25.07 | 23.83 | 24.22 |
| CDMA PCS EVDO (Rev.0) | Conducted Power(dBm) | | |
| | Channel 25 | Channel 600 | Channel 1175 |

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA2010-0916

Page 18 of 83

| | | | |
|------------------------------|-----------------------------|-------------|--------------|
| Before test | 24.11 | 23.33 | 23.51 |
| After test | 24.13 | 23.30 | 23.54 |
| CDMA PCS EVDO (Rev.A) | Conducted Power(dBm) | | |
| | Channel 25 | Channel 600 | Channel 1175 |
| Before test | 24.11 | 23.28 | 23.51 |
| After test | 24.11 | 23.24 | 23.48 |
| CDMA AWS (RC3) | Conducted Power(dBm) | | |
| | Channel 25 | Channel 450 | Channel 850 |
| Before test | 24.61 | 24.85 | 24.42 |
| After test | 24.65 | 24.86 | 24.46 |
| CDMA AWS (RC1) | Conducted Power(dBm) | | |
| | Channel 25 | Channel 450 | Channel 850 |
| Before test | 24.62 | 24.81 | 24.40 |
| After test | 24.65 | 24.85 | 24.37 |
| CDMA AWS EVDO (Rev.0) | Conducted Power(dBm) | | |
| | Channel 25 | Channel 450 | Channel 850 |
| Before test | 24.03 | 24.11 | 23.56 |
| After test | 24.01 | 24.08 | 23.54 |
| CDMA AWS EVDO (Rev.A) | Conducted Power(dBm) | | |
| | Channel 25 | Channel 450 | Channel 850 |
| Before test | 24.03 | 24.11 | 23.50 |
| After test | 24.03 | 24.10 | 23.53 |

TA Technology (Shanghai) Co., Ltd.
Test Report

3. Test Results

3.1. ANSI C63.19-2007 Limits

| Category | | Telephone RF parameters < 960 MHz | | | |
|----------------|-----|-----------------------------------|-----|-------------------|-----|
| Near field | AWF | E-field emissions | | H-field emissions | |
| Category M1/T1 | 0 | 631.0 to 1122.0 | V/m | 1.91 to 3.39 | A/m |
| | -5 | 473.2 to 841.4 | V/m | 1.43 to 2.54 | A/m |
| Category M2/T2 | 0 | 354.8 to 631.0 | V/m | 1.07 to 1.91 | A/m |
| | -5 | 266.1 to 473.2 | V/m | 0.80 to 1.43 | A/m |
| Category M3/T3 | 0 | 199.5 to 354.8 | V/m | 0.60 to 1.07 | A/m |
| | -5 | 149.6 to 266.1 | V/m | 0.45 to 0.80 | A/m |
| Category M4/T4 | 0 | < 199.5 | V/m | < 0.60 | A/m |
| | -5 | < 149.6 | V/m | < 0.45 | A/m |
| Category | | Telephone RF parameters > 960 MHz | | | |
| Near field | AWF | E-field emissions | | H-field emissions | |
| Category M1/T1 | 0 | 199.5 to 354.8 | V/m | 0.60 to 1.07 | A/m |
| | -5 | 149.6 to 266.1 | V/m | 0.45 to 0.80 | A/m |
| Category M2/T2 | 0 | 112.2 to 199.5 | V/m | 0.34 to 0.60 | A/m |
| | -5 | 84.1 to 149.6 | V/m | 0.25 to 0.45 | A/m |
| Category M3/T3 | 0 | 63.1 to 112.2 | V/m | 0.19 to 0.34 | A/m |
| | -5 | 47.3 to 84.1 | V/m | 0.14 to 0.25 | A/m |
| Category M4/T4 | 0 | < 63.1 | V/m | < 0.19 | A/m |
| | -5 | < 47.3 | V/m | < 0.14 | A/m |

TA Technology (Shanghai) Co., Ltd.
Test Report

3.2. Summary Test Results

CDMA Cellular Results

| E-Field | | | | | |
|---------|-----------------|------------------|------------------|--------|---------------|
| Channel | Frequency (MHz) | Peak Field (V/m) | Power Drift (dB) | Rating | Graph Results |
| 777 | 848.31 | 77.500 | -0.001 | M4 | Figure 12 |
| 384 | 836.52 | 72.100 | -0.010 | M4 | Figure 13 |
| 1013 | 824.70 | 62.400 | -0.004 | M4 | Figure 14 |
| H-Field | | | | | |
| Channel | Frequency (MHz) | Peak Field (A/m) | Power Drift (dB) | Rating | Graph Results |
| 777 | 848.31 | 0.116 | 0.055 | M4 | Figure 15 |
| 384 | 836.52 | 0.107 | -0.055 | M4 | Figure 16 |
| 1013 | 824.70 | 0.090 | 0.133 | M4 | Figure 17 |

CDMA PCS Results

| E-Field | | | | | |
|---------|-----------------|------------------|------------------|--------|---------------|
| Channel | Frequency (MHz) | Peak Field (V/m) | Power Drift (dB) | Rating | Graph Results |
| 1175 | 1908.75 | 23.800 | -0.122 | M4 | Figure 18 |
| 600 | 1880 | 21.700 | -0.125 | M4 | Figure 19 |
| 25 | 1851.25 | 20.300 | -0.012 | M4 | Figure 20 |
| H-Field | | | | | |
| Channel | Frequency (MHz) | Peak Field (A/m) | Power Drift (dB) | Rating | Graph Results |
| 1175 | 1908.75 | 0.060 | -0.054 | M4 | Figure 21 |
| 600 | 1880 | 0.063 | -0.161 | M4 | Figure 22 |
| 25 | 1851.25 | 0.065 | 0.092 | M4 | Figure 23 |

CDMA AWS Results

| E-Field | | | | | |
|---------|-----------------|------------------|------------------|--------|---------------|
| Channel | Frequency (MHz) | Peak Field (V/m) | Power Drift (dB) | Rating | Graph Results |
| 850 | 1752.5 | 22.000 | 0.041 | M4 | Figure 24 |
| 450 | 1732.5 | 24.400 | -0.005 | M4 | Figure 25 |
| 25 | 1711.25 | 25.500 | 0.061 | M4 | Figure 26 |
| H-Field | | | | | |
| Channel | Frequency (MHz) | Peak Field (A/m) | Power Drift (dB) | Rating | Graph Results |
| 850 | 1752.5 | 0.063 | -0.009 | M4 | Figure 27 |
| 450 | 1732.5 | 0.071 | -0.012 | M4 | Figure 28 |
| 25 | 1711.25 | 0.077 | -0.132 | M4 | Figure 29 |

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA2010-0916

Page 21 of 83

4. Measurement Uncertainty

| No. | Error source | Type | Uncertainty Value (%) | Prob. Dist. | k | c_{iE} | c_{iH} | Standard Uncertainty (%) u_i (%) E | Standard Uncertainty (%) u_i (%) H | Degree of freedom V_{eff} or v_i |
|----------------------------|--------------------------------|------|-----------------------|-------------|------------|----------|----------|---|---|---|
| Measurement System | | | | | | | | | | |
| 1 | Probe Calibration | B | 5. | N | 1 | 1 | 1 | 5.1 | 5.1 | ∞ |
| 2 | Axial Isotropy | B | 4.7 | R | $\sqrt{3}$ | 1 | 1 | 2.7 | 2.7 | ∞ |
| 3 | Sensor Displacement | B | 16.5 | R | $\sqrt{3}$ | 1 | 0.145 | 9.5 | 1.4 | ∞ |
| 4 | Boundary Effects | B | 2.4 | R | $\sqrt{3}$ | 1 | 1 | 1.4 | 1.4 | ∞ |
| 5 | Linearity | B | 4.7 | R | $\sqrt{3}$ | 1 | 1 | 2.7 | 2.7 | ∞ |
| 6 | Scaling to Peak Envelope Power | B | 2.0 | R | $\sqrt{3}$ | 1 | 1 | 1.2 | 1.2 | ∞ |
| 7 | System Detection Limit | B | 1.0 | R | $\sqrt{3}$ | 1 | 1 | 0.6 | 0.6 | ∞ |
| 8 | Readout Electronics | B | 0.3 | N | 1 | 1 | 1 | 0.3 | 0.3 | ∞ |
| 9 | Response Time | B | 0.8 | R | $\sqrt{3}$ | 1 | 1 | 0.5 | 0.5 | ∞ |
| 10 | Integration Time | B | 2.6 | R | $\sqrt{3}$ | 1 | 1 | 1.5 | 1.5 | ∞ |
| 11 | RF Ambient Conditions | B | 3.0 | R | $\sqrt{3}$ | 1 | 1 | 1.7 | 1.7 | ∞ |
| 12 | RF Reflections | B | 12.0 | R | $\sqrt{3}$ | 1 | 1 | 6.9 | 6.9 | ∞ |
| 13 | Probe Positioner | B | 1.2 | R | $\sqrt{3}$ | 1 | 0.67 | 0.7 | 0.5 | ∞ |
| 14 | Probe Positioning | A | 4.7 | R | $\sqrt{3}$ | 1 | 0.67 | 2.7 | 1.8 | ∞ |
| 15 | Extra. And Interpolation | B | 1.0 | R | $\sqrt{3}$ | 1 | 1 | 0.6 | 0.6 | ∞ |
| Test Sample Related | | | | | | | | | | |
| 16 | Device Positioning Vertical | B | 4.7 | R | $\sqrt{3}$ | 1 | 0.67 | 2.7 | 1.8 | ∞ |
| 17 | Device Positioning Lateral | B | 1.0 | R | $\sqrt{3}$ | 1 | 1 | 0.6 | 0.6 | ∞ |
| 18 | Device Holder and Phantom | B | 2.4 | R | $\sqrt{3}$ | 1 | 1 | 1.4 | 1.4 | ∞ |

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA2010-0916

Page 22 of 83

| | | | | | | | | | | |
|--|-------------------|--------------|-----|---|------------|---|------|------|------|----------|
| 19 | Power Drift | B | 5.0 | R | $\sqrt{3}$ | 1 | 1 | 2.9 | 2.9 | ∞ |
| Phantom and Setup related | | | | | | | | | | |
| 20s | Phantom Thickness | B | 2.4 | R | $\sqrt{3}$ | 1 | 0.67 | 1.4 | 0.9 | ∞ |
| Combined standard uncertainty(%) | | | | | | | | 14.7 | 10.9 | |
| Expanded uncertainty (confidence interval of 95 %) | | $u_e = 2u_c$ | | N | k=2 | | | 29.4 | 21.8 | |

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA2010-0916

Page 23 of 83

5. Main Test Instruments

| No. | Name | Type | Serial Number | Calibration Date | Valid Period |
|-----|------------------------|----------------|---------------|--------------------------|--------------|
| 01 | Power meter | Agilent E4417A | GB41291714 | March 13, 2010 | One year |
| 02 | Power sensor | Agilent 8481H | MY41091316 | March 26, 2010 | One year |
| 03 | Signal Generator | HP 8341B | 2730A00804 | September 13, 2009 | One year |
| 04 | Amplifier | IXA-020 | 0401 | No Calibration Requested | |
| 05 | BTS | E5515C | MY48360988 | December 4, 2009 | One year |
| 06 | E-Field Probe | ER3DV6 | 2428 | October 20, 2009 | One year |
| 07 | H-Field Probe | H3DV6 | 6260 | October 20, 2009 | One year |
| 08 | DAE | DAE4 | 871 | November 11, 2009 | One year |
| 09 | Validation Kit 835MHz | CD835V3 | 1149 | January 12, 2010 | One year |
| 10 | Validation Kit 1880MHz | CD1880V3 | 1135 | January 13, 2010 | One year |

*****END OF REPORT BODY*****

ANNEX A: System Check Results

HAC_System Performance Check at 835MHz_E

DUT: Dipole 835 MHz; Type: CD835V3; SN:1149

Date/Time: 6/22/2010 1:17:32 AM

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY4 Configuration:

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/11/2009

Phantom: HAC Test Arch; Type: SD HAC P01 BA;

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm/Hearing Aid Compatibility Test (41x361x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 149.2 V/m

Probe Modulation Factor = 1.00

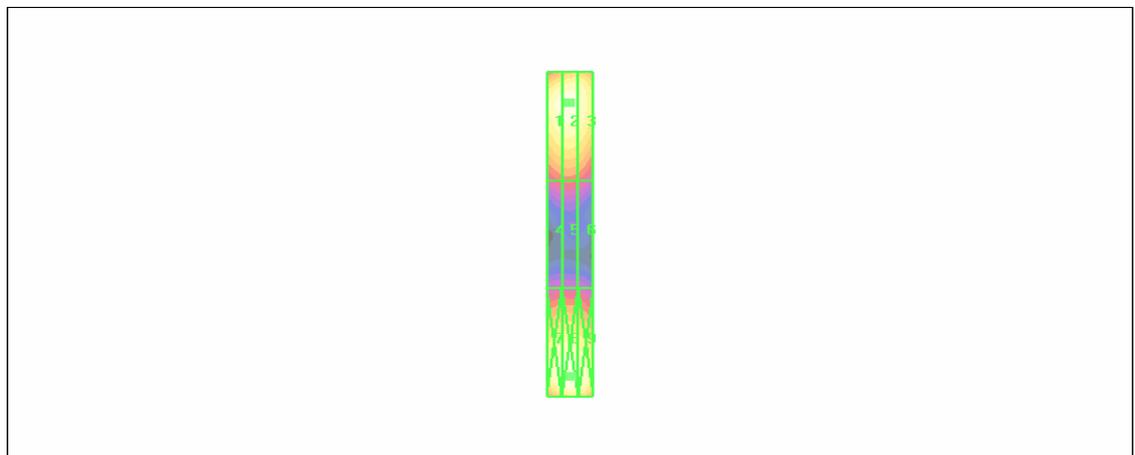
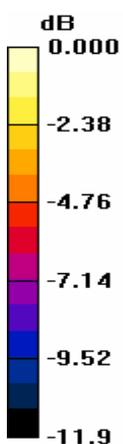
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 100.7 V/m; Power Drift = -0.066 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

| | | |
|---------------------------|---------------------------|---------------------------|
| Grid 1 147.0 M4 | Grid 2 149.2 M4 | Grid 3 143.9 M4 |
| Grid 4 83.4 M4 | Grid 5 85.0 M4 | Grid 6 81.1 M4 |
| Grid 7 148.8 M4 | Grid 8 154.0 M4 | Grid 9 148.9 M4 |



0 dB = 154.0V/m

Figure 8 System Performance Check 835MHz_E

TA Technology (Shanghai) Co., Ltd. Test Report

HAC_System Performance Check at 835MHz_H

DUT: Dipole 835 MHz; Type: CD835V3; SN: 1149

Date/Time: 6/22/2010 2:09:58 AM

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY4 Configuration:

Probe: H3DV6 - SN6260 ; Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/11/2009

Phantom: HAC Test Arch; Type: SD HAC P01 BA;

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm/Hearing Aid Compatibility Test (41x361x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.443 A/m

Probe Modulation Factor = 1.00

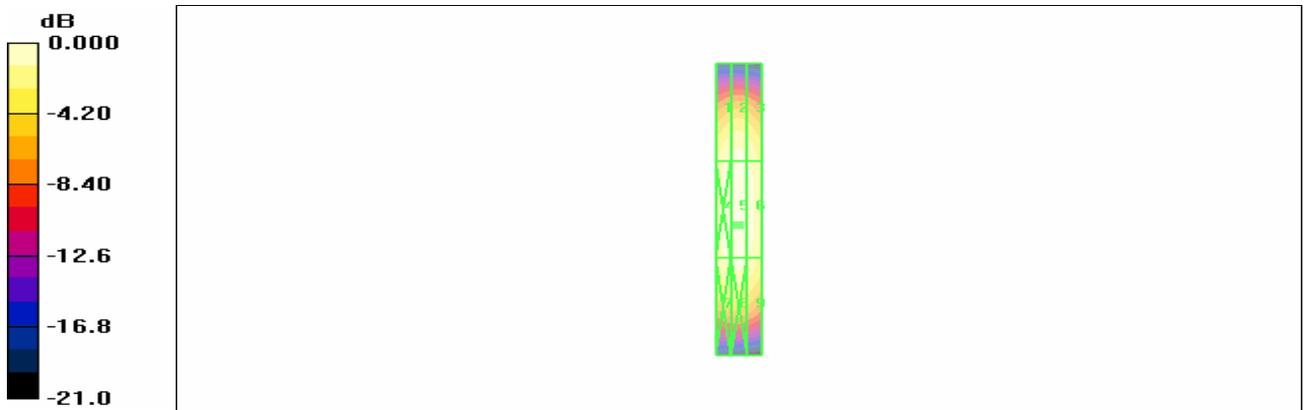
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.464 A/m; Power Drift = 0.019 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

| | | |
|---------------------------|---------------------------|---------------------------|
| Grid 1 0.391 M4 | Grid 2 0.408 M4 | Grid 3 0.384 M4 |
| Grid 4 0.427 M4 | Grid 5 0.443 M4 | Grid 6 0.414 M4 |
| Grid 7 0.397 M4 | Grid 8 0.410 M4 | Grid 9 0.381 M4 |



0 dB = 0.443A/m

Figure 9 System Performance Check 835MHz_H

TA Technology (Shanghai) Co., Ltd. Test Report

HAC_System Performance Check at 1880MHz_E

DUT: Dipole 1880 MHz; Type: CD1880V3; SN:1135

Date/Time: 6/22/2010 1:46:34 AM

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY4 Configuration:

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/11/2009

Phantom: HAC Test Arch; Type: SD HAC P01 BA;

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10mm/Hearing Aid Compatibility Test (41x181x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 131.4 V/m

Probe Modulation Factor = 1.00

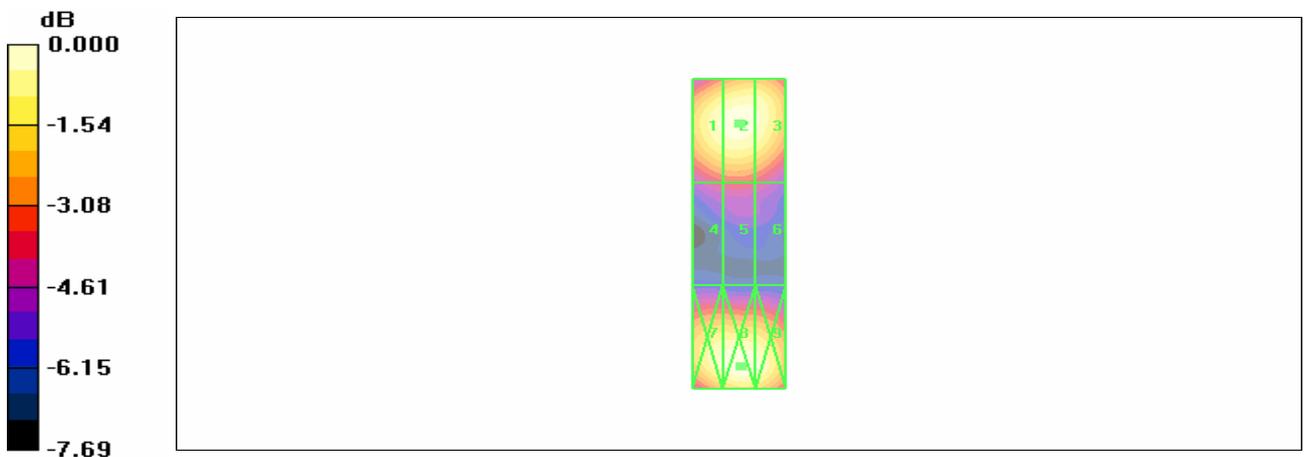
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 151.0 V/m; Power Drift = -0.047 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak E-field in V/m

| | | |
|---------------------------|---------------------------|---------------------------|
| Grid 1 128.5 M2 | Grid 2 131.4 M2 | Grid 3 128.5 M2 |
| Grid 4 87.5 M3 | Grid 5 89.7 M3 | Grid 6 86.2 M3 |
| Grid 7 128.7 M2 | Grid 8 134.0 M2 | Grid 9 130.3 M2 |



0 dB = 134.0V/m

Figure 10 System Performance Check 1880MHz_E

TA Technology (Shanghai) Co., Ltd. Test Report

HAC_System Performance Check at 1880MHz_H

DUT: Dipole 1880 MHz; Type: CD1880V3; SN:1135

Date/Time: 6/22/2010 12:49:22 AM

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY4 Configuration:

Probe: H3DV6 - SN6260; Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/11/2009

Phantom: HAC Test Arch; Type: SD HAC P01 BA;

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan - measurement distance from the probe sensor center to Dipole = 10mm/Hearing Aid

Compatibility Test (41x181x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.449 A/m

Probe Modulation Factor = 1.00

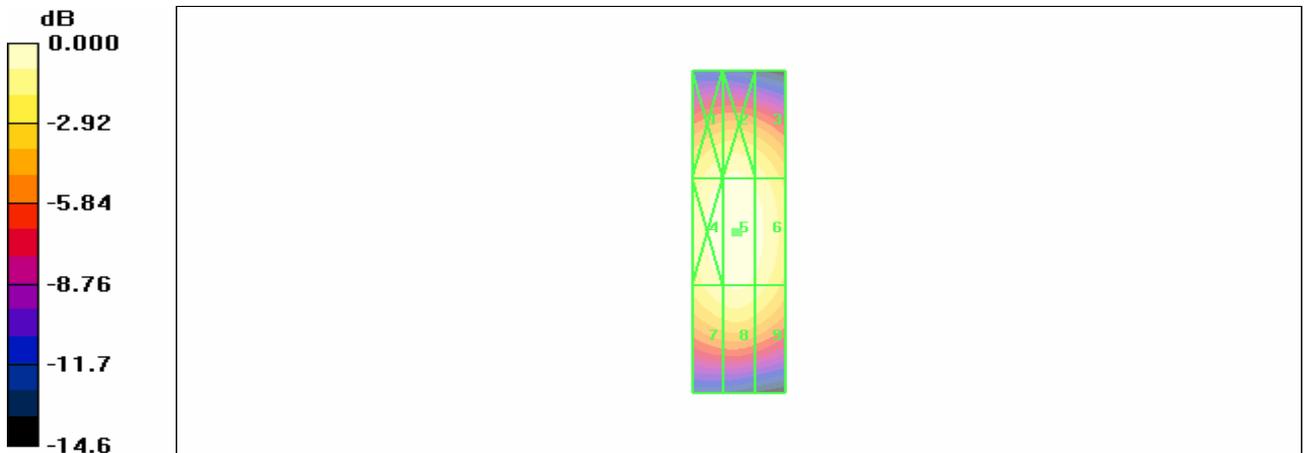
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.472 A/m; Power Drift = -0.005 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak H-field in A/m

| | | |
|-----------------|-----------------|-----------------|
| Grid 1 | Grid 2 | Grid 3 |
| 0.400 M2 | 0.413 M2 | 0.387 M2 |
| Grid 4 | Grid 5 | Grid 6 |
| 0.435 M2 | 0.449 M2 | 0.422 M2 |
| Grid 7 | Grid 8 | Grid 9 |
| 0.397 M2 | 0.410 M2 | 0.384 M2 |



0 dB = 0.449A/m

Figure 11 System Performance Check 1880MHz_H

ANNEX B: Graph Results

HAC RF E-Field CDMA Cellular High

Date/Time: 6/22/2010 3:27:05 AM

Communication System: CDMA Cellular; Frequency: 848.31 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY4 Configuration:

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/11/2009

Phantom: HAC Test Arch; Type: SD HAC P01 BA;

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 77.5 V/m

Probe Modulation Factor = 1.00

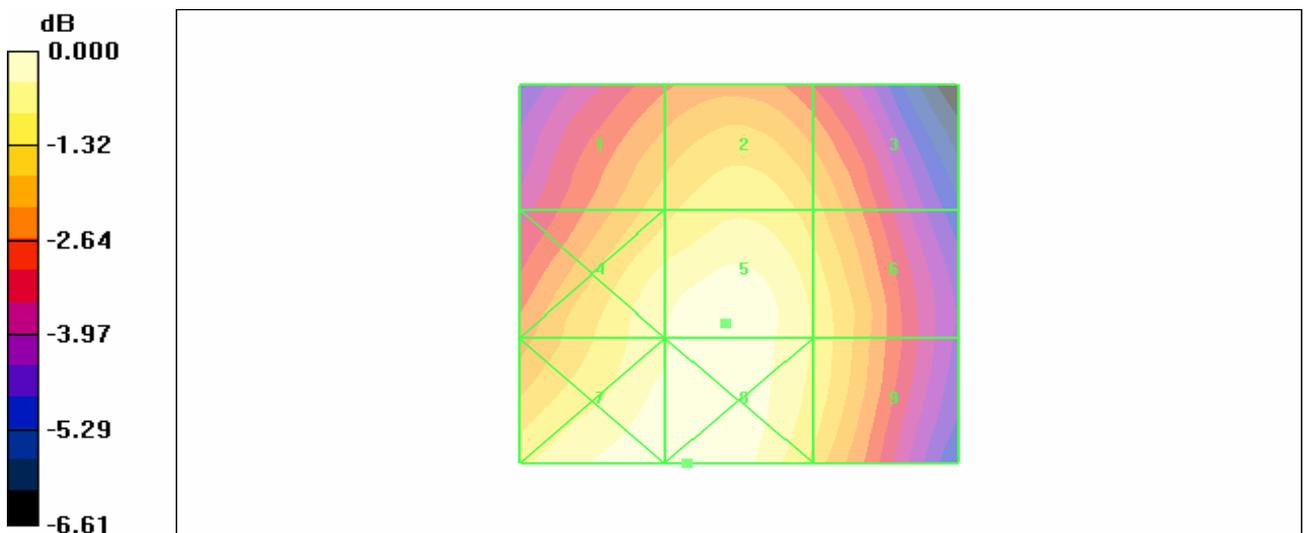
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 98.3 V/m; Power Drift = -0.001 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

| | | |
|--------------------------|--------------------------|--------------------------|
| Grid 1 66.6 M4 | Grid 2 70.9 M4 | Grid 3 65.8 M4 |
| Grid 4 74.8 M4 | Grid 5 77.5 M4 | Grid 6 70.8 M4 |
| Grid 7 78.5 M4 | Grid 8 78.9 M4 | Grid 9 70.8 M4 |



0 dB = 78.9V/m

Figure 12 HAC RF E-Field CDMA Cellular Channel 777

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA2010-0916

Page 29 of 83

HAC RF E-Field CDMA Cellular Middle

Date/Time: 6/22/2010 3:31:48 AM

Communication System: CDMA Cellular; Frequency: 836.52 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY4 Configuration:

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/11/2009

Phantom: HAC Test Arch; Type: SD HAC P01 BA;

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 72.1 V/m

Probe Modulation Factor = 1.00

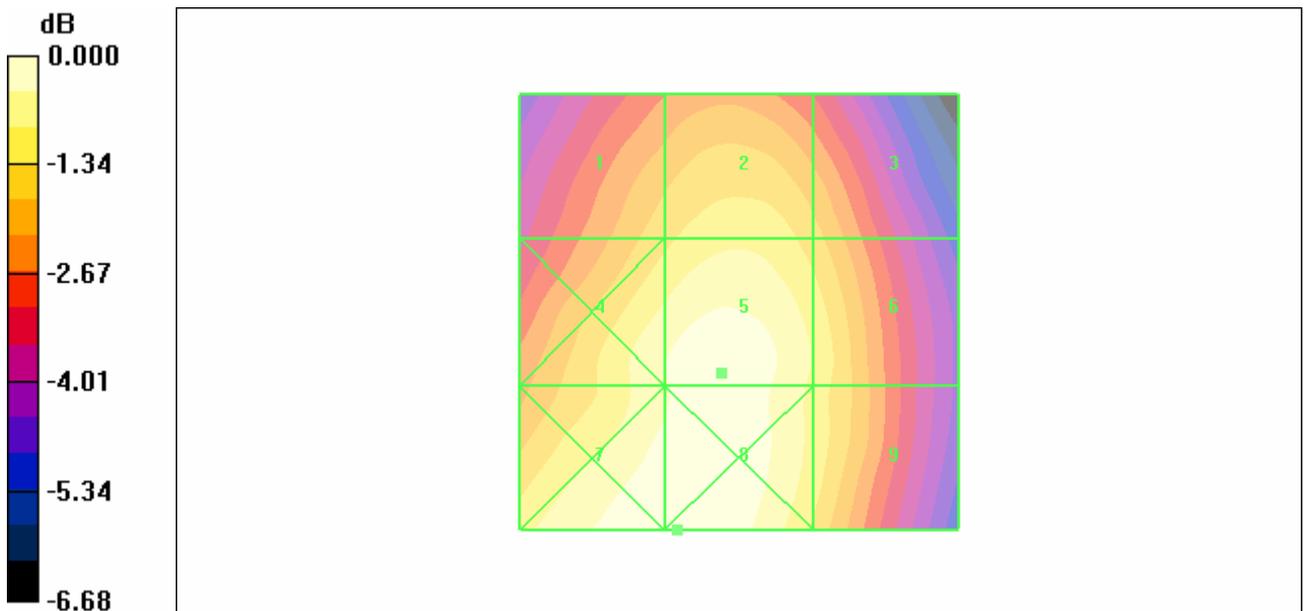
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 91.4 V/m; Power Drift = -0.010 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

| | | |
|--------------------------|--------------------------|--------------------------|
| Grid 1 62.1 M4 | Grid 2 65.5 M4 | Grid 3 61.2 M4 |
| Grid 4 69.8 M4 | Grid 5 72.1 M4 | Grid 6 66.1 M4 |
| Grid 7 73.4 M4 | Grid 8 73.5 M4 | Grid 9 65.4 M4 |



0 dB = 73.5V/m

Figure 13 HAC RF E-Field CDMA Cellular Channel 384

TA Technology (Shanghai) Co., Ltd. Test Report

HAC RF E-Field CDMA Cellular Low

Date/Time: 6/22/2010 3:36:40 AM

Communication System: CDMA Cellular; Frequency: 824.7 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY4 Configuration:

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/11/2009

Phantom: HAC Test Arch; Type: SD HAC P01 BA;

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 62.4 V/m

Probe Modulation Factor = 1.00

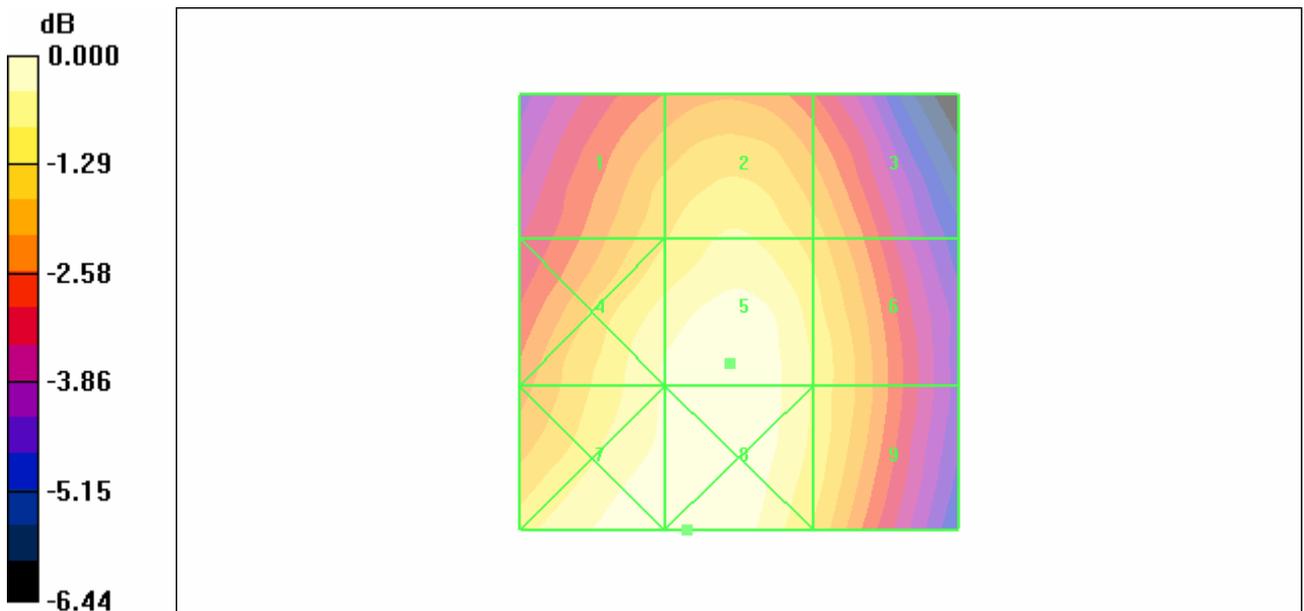
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 79.4 V/m; Power Drift = -0.004 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

| | | |
|--------------------------|--------------------------|--------------------------|
| Grid 1 54.1 M4 | Grid 2 57.6 M4 | Grid 3 53.1 M4 |
| Grid 4 60.2 M4 | Grid 5 62.4 M4 | Grid 6 56.9 M4 |
| Grid 7 62.7 M4 | Grid 8 63.1 M4 | Grid 9 56.7 M4 |



0 dB = 63.1V/m

Figure 14 HAC RF E-Field CDMA Cellular Channel 1013

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA2010-0916

Page 31 of 83

HAC RF H-Field CDMA Cellular High

Date/Time: 6/22/2010 5:17:13 AM

Communication System: CDMA Cellular; Frequency: 848.31 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY4 Configuration:

Probe: H3DV6 - SN6260; Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/11/2009

Phantom: HAC Test Arch; Type: SD HAC P01 BA;

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan - H3DV6: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.116 A/m

Probe Modulation Factor = 1.00

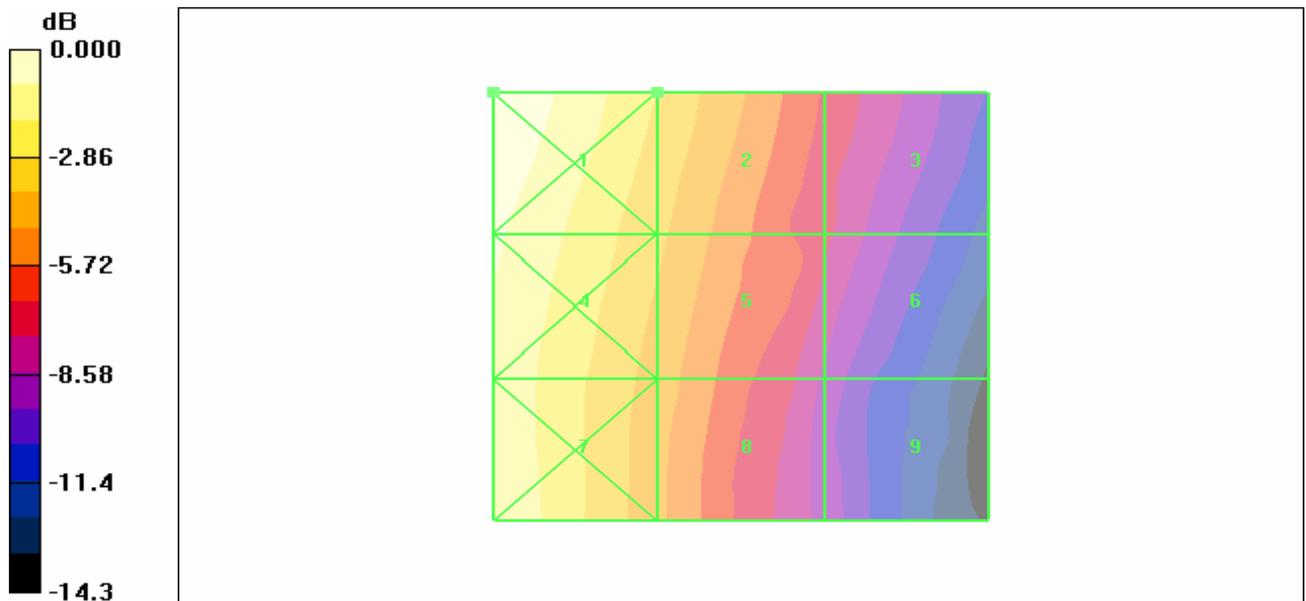
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.085 A/m; Power Drift = 0.055 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

| | | |
|---------------------------|---------------------------|---------------------------|
| Grid 1 0.162 M4 | Grid 2 0.116 M4 | Grid 3 0.074 M4 |
| Grid 4 0.148 M4 | Grid 5 0.107 M4 | Grid 6 0.069 M4 |
| Grid 7 0.143 M4 | Grid 8 0.099 M4 | Grid 9 0.059 M4 |



0 dB = 0.162A/m

Figure 15 HAC RF H-Field CDMA Cellular Channel 777

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA2010-0916

Page 32 of 83

HAC RF H-Field CDMA Cellular Middle

Date/Time: 6/22/2010 5:12:30 AM

Communication System: CDMA Cellular; Frequency: 836.52 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY4 Configuration:

Probe: H3DV6 - SN6260; Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/11/2009

Phantom: HAC Test Arch; Type: SD HAC P01 BA;

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan - H3DV6: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.107 A/m

Probe Modulation Factor = 1.00

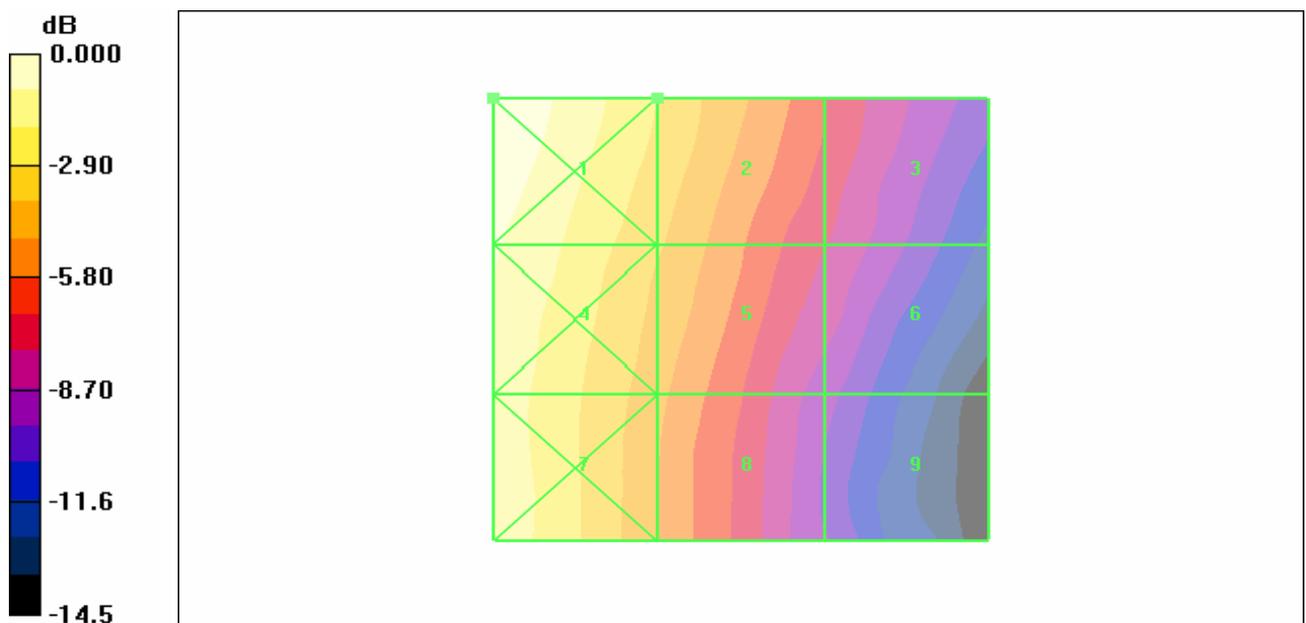
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.077 A/m; Power Drift = -0.055 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

| | | |
|---------------------------|---------------------------|---------------------------|
| Grid 1 0.149 M4 | Grid 2 0.107 M4 | Grid 3 0.069 M4 |
| Grid 4 0.135 M4 | Grid 5 0.097 M4 | Grid 6 0.062 M4 |
| Grid 7 0.130 M4 | Grid 8 0.089 M4 | Grid 9 0.052 M4 |



0 dB = 0.149A/m

Figure 16 HAC RF H-Field CDMA Cellular Channel 384

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA2010-0916

Page 33 of 83

HAC RF H-Field CDMA Cellular Low

Date/Time: 6/22/2010 5:07:42 AM

Communication System: CDMA Cellular; Frequency: 824.7 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY4 Configuration:

Probe: H3DV6 - SN6260; Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/11/2009

Phantom: HAC Test Arch; Type: SD HAC P01 BA;

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan - H3DV6: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.090 A/m

Probe Modulation Factor = 1.00

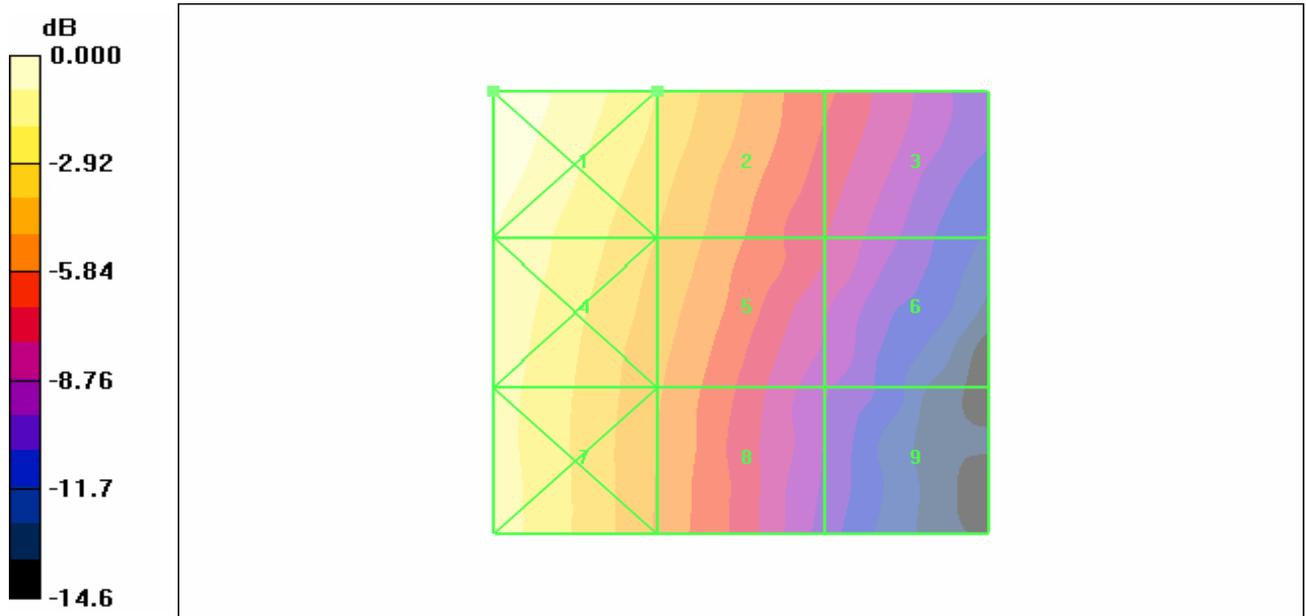
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.063 A/m; Power Drift = 0.133 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

| | | |
|---------------------------|---------------------------|---------------------------|
| Grid 1 0.126 M4 | Grid 2 0.090 M4 | Grid 3 0.059 M4 |
| Grid 4 0.113 M4 | Grid 5 0.080 M4 | Grid 6 0.052 M4 |
| Grid 7 0.108 M4 | Grid 8 0.073 M4 | Grid 9 0.042 M4 |



0 dB = 0.126A/m

Figure 17 HAC RF H-Field CDMA Cellular Channel 1013

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA2010-0916

Page 34 of 83

HAC RF E-Field CDMA PCS High

Date/Time: 6/22/2010 2:56:58 AM

Communication System: CDMA PCS; Frequency: 1908.75 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY4 Configuration:

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/11/2009

Phantom: HAC Test Arch; Type: SD HAC P01 BA;

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 23.8 V/m

Probe Modulation Factor = 1.00

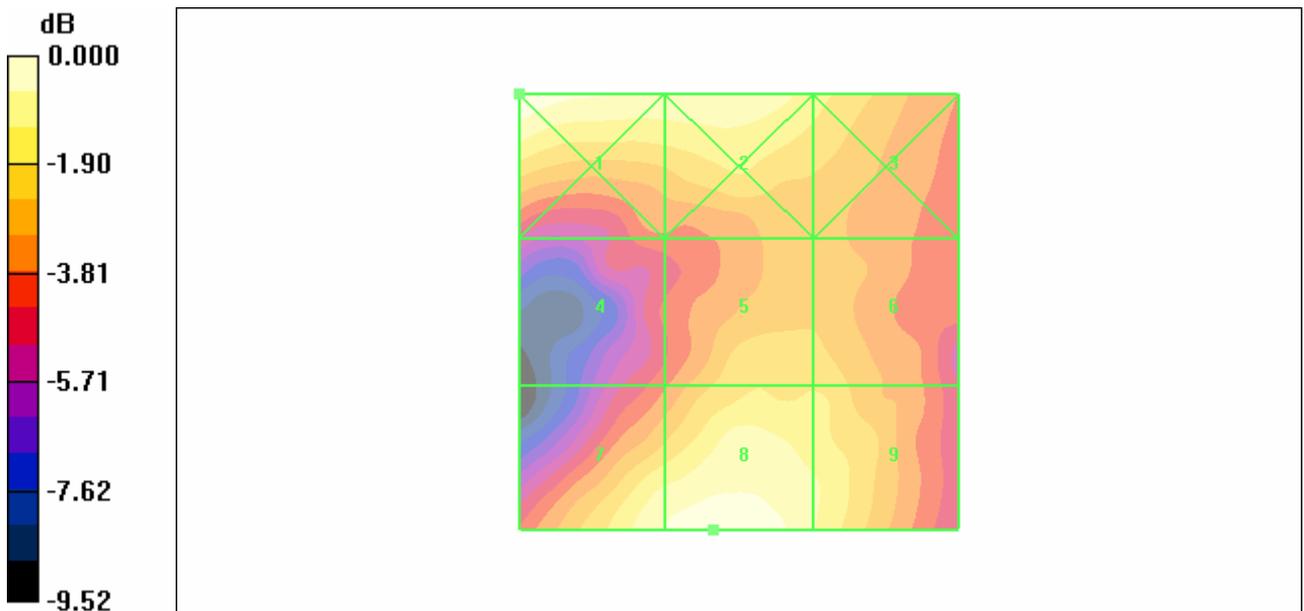
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 21.0 V/m; Power Drift = -0.122 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

| | | |
|--------------------------|--------------------------|--------------------------|
| Grid 1 24.3 M4 | Grid 2 22.6 M4 | Grid 3 20.2 M4 |
| Grid 4 15.5 M4 | Grid 5 19.5 M4 | Grid 6 19.4 M4 |
| Grid 7 22.7 M4 | Grid 8 23.8 M4 | Grid 9 21.3 M4 |



0 dB = 24.3V/m

Figure 18 HAC RF E-Field CDMA PCS Channel 1175

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA2010-0916

Page 35 of 83

HAC RF E-Field CDMA PCS Middle

Date/Time: 6/22/2010 3:02:04 AM

Communication System: CDMA PCS; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY4 Configuration:

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/11/2009

Phantom: HAC Test Arch; Type: SD HAC P01 BA;

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan - ER3D - 2007: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 21.7 V/m

Probe Modulation Factor = 1.00

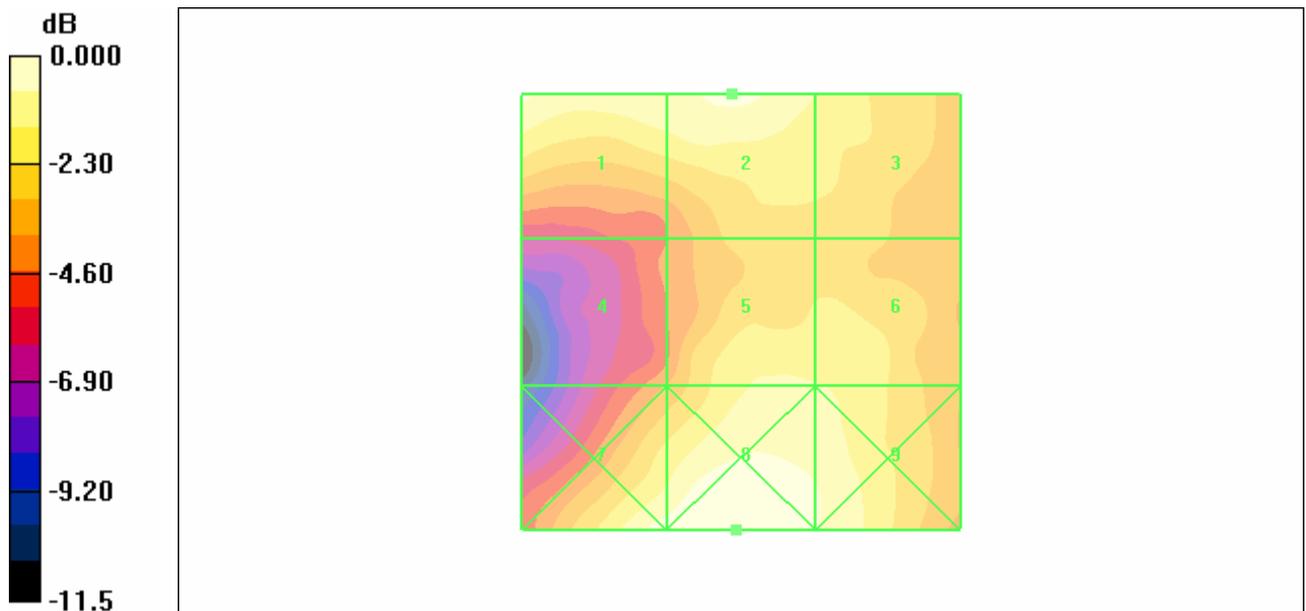
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 20.7 V/m; Power Drift = -0.125 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

| | | |
|--------------------------|--------------------------|--------------------------|
| Grid 1 21.6 M4 | Grid 2 21.7 M4 | Grid 3 19.4 M4 |
| Grid 4 14.9 M4 | Grid 5 19.5 M4 | Grid 6 19.4 M4 |
| Grid 7 22.1 M4 | Grid 8 23.0 M4 | Grid 9 21.3 M4 |



0 dB = 23.0V/m

Figure 19 HAC RF E-Field CDMA PCS Channel 600

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA2010-0916

Page 36 of 83

HAC RF E-Field CDMA PCS Low

Date/Time: 6/22/2010 3:06:56 AM

Communication System: CDMA PCS; Frequency: 1851.25 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY4 Configuration:

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/11/2009

Phantom: HAC Test Arch; Type: SD HAC P01 BA;

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 20.3 V/m

Probe Modulation Factor = 1.00

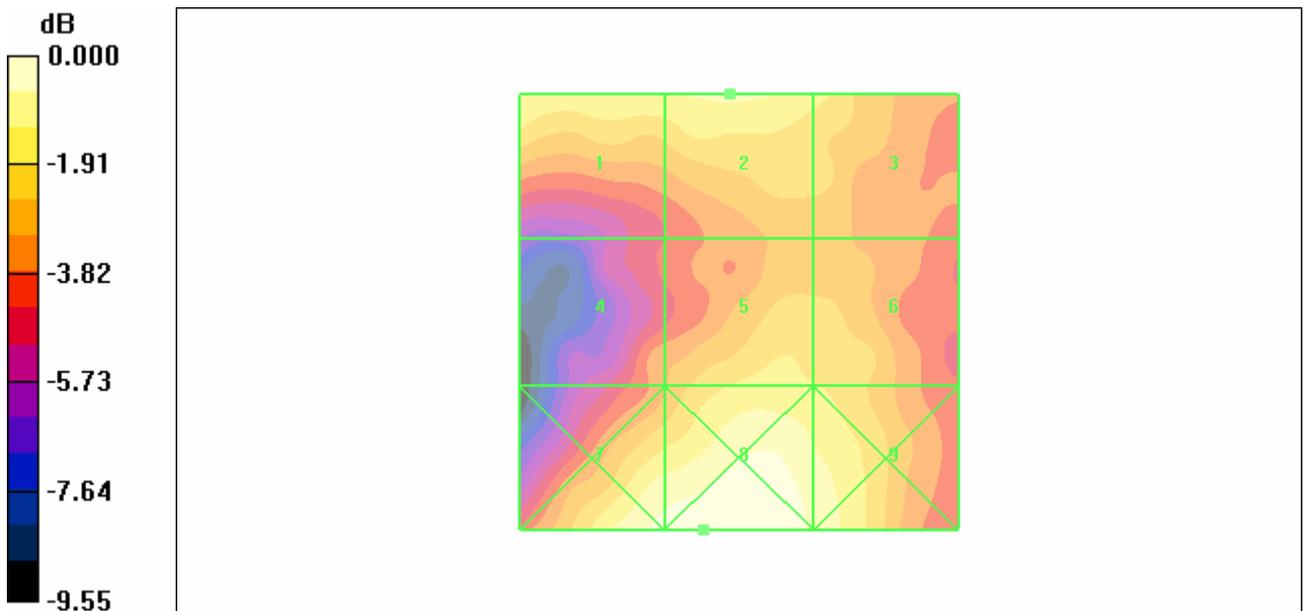
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 20.6 V/m; Power Drift = -0.012 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

| | | |
|--------------------------|--------------------------|--------------------------|
| Grid 1 20.2 M4 | Grid 2 20.3 M4 | Grid 3 19.1 M4 |
| Grid 4 15.9 M4 | Grid 5 19.1 M4 | Grid 6 18.7 M4 |
| Grid 7 22.1 M4 | Grid 8 23.1 M4 | Grid 9 21.2 M4 |



0 dB = 23.1V/m

Figure 20 HAC RF E-Field CDMA PCS Channel 25

TA Technology (Shanghai) Co., Ltd. Test Report

HAC RF H-Field CDMA PCS High

Date/Time: 6/22/2010 5:43:16 AM

Communication System: CDMA PCS; Frequency: 1908.75 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY4 Configuration:

Probe: H3DV6 - SN6260; Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/11/2009

Phantom: HAC Test Arch; Type: SD HAC P01 BA;

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan - H3DV6: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.060 A/m

Probe Modulation Factor = 1.00

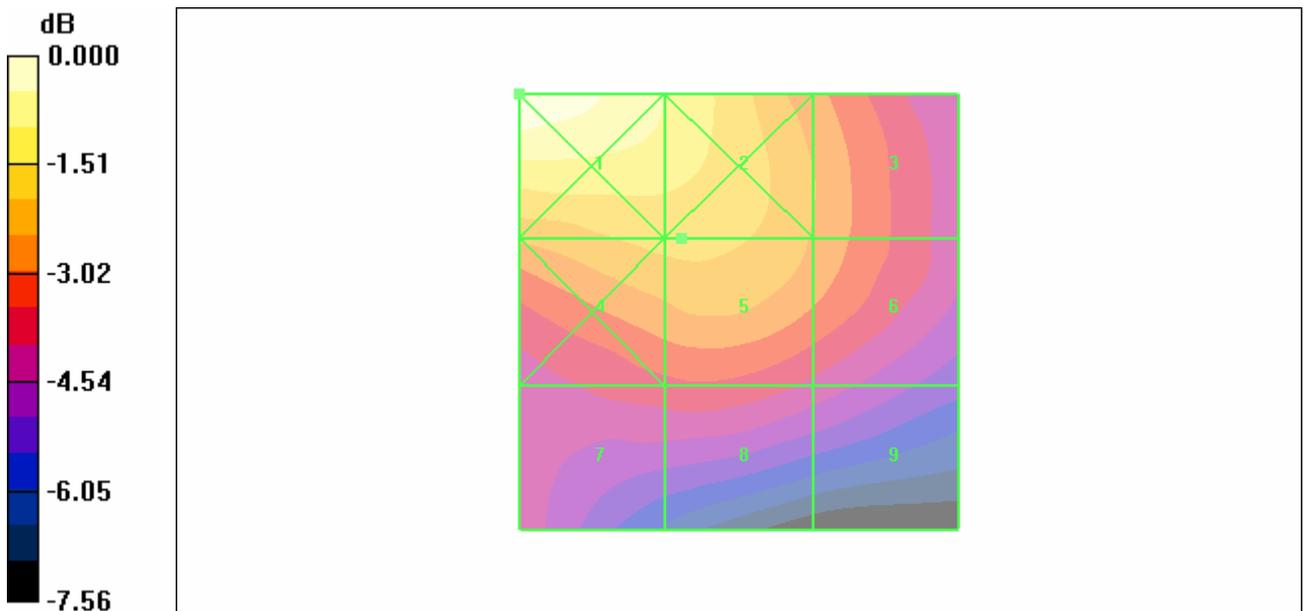
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.063 A/m; Power Drift = -0.054 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

| | | |
|---------------------------|---------------------------|---------------------------|
| Grid 1 0.075 M4 | Grid 2 0.067 M4 | Grid 3 0.056 M4 |
| Grid 4 0.060 M4 | Grid 5 0.060 M4 | Grid 6 0.056 M4 |
| Grid 7 0.049 M4 | Grid 8 0.050 M4 | Grid 9 0.046 M4 |



0 dB = 0.075A/m

Figure 21 HAC RF H-Field CDMA PCS Channel 1175

TA Technology (Shanghai) Co., Ltd. Test Report

HAC RF H-Field CDMA PCS Middle

Date/Time: 6/22/2010 5:38:14 AM

Communication System: CDMA PCS; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY4 Configuration:

Probe: H3DV6 - SN6260; Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/11/2009

Phantom: HAC Test Arch; Type: SD HAC P01 BA;

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan - H3DV6: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.063 A/m

Probe Modulation Factor = 1.00

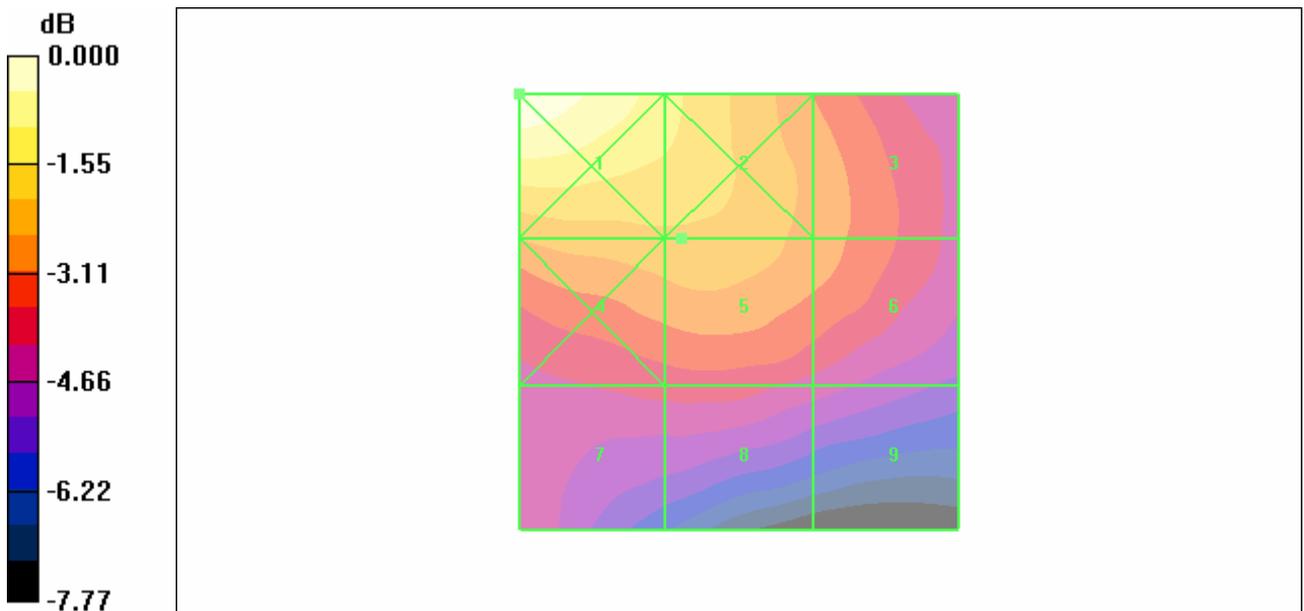
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.067 A/m; Power Drift = -0.161 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

| | | |
|-----------------|-----------------|-----------------|
| Grid 1 | Grid 2 | Grid 3 |
| 0.081 M4 | 0.070 M4 | 0.059 M4 |
| Grid 4 | Grid 5 | Grid 6 |
| 0.063 M4 | 0.063 M4 | 0.059 M4 |
| Grid 7 | Grid 8 | Grid 9 |
| 0.052 M4 | 0.052 M4 | 0.049 M4 |



0 dB = 0.081A/m

Figure 22 HAC RF H-Field CDMA PCS Channel 600

TA Technology (Shanghai) Co., Ltd. Test Report

HAC RF H-Field CDMA PCS Low

Date/Time: 6/22/2010 5:33:22 AM

Communication System: CDMA PCS; Frequency: 1851.25 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY4 Configuration:

Probe: H3DV6 - SN6260; Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/11/2009

Phantom: HAC Test Arch; Type: SD HAC P01 BA;

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan - H3DV6: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.065 A/m

Probe Modulation Factor = 1.00

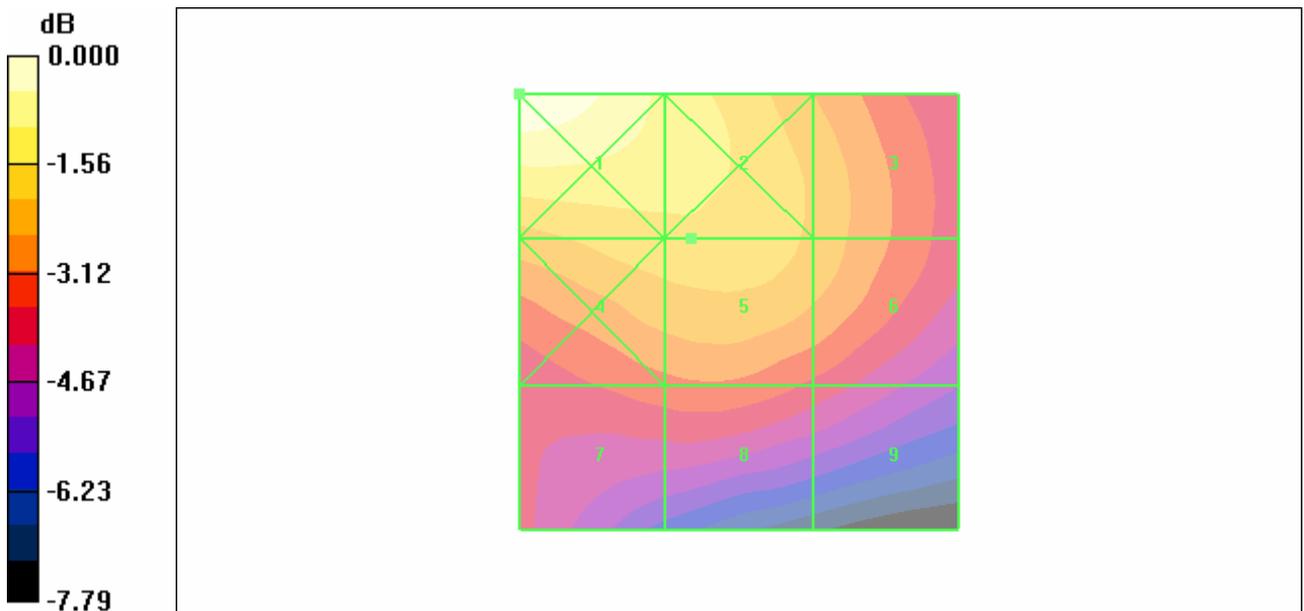
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.069 A/m; Power Drift = 0.092 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

| | | |
|---------------------------|---------------------------|---------------------------|
| Grid 1 0.079 M4 | Grid 2 0.069 M4 | Grid 3 0.062 M4 |
| Grid 4 0.065 M4 | Grid 5 0.065 M4 | Grid 6 0.061 M4 |
| Grid 7 0.054 M4 | Grid 8 0.055 M4 | Grid 9 0.051 M4 |



0 dB = 0.079A/m

Figure 23 HAC RF H-Field CDMA PCS Channel 25

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA2010-0916

Page 40 of 83

HAC RF E-Field CDMA AWS High

Date/Time: 6/22/2010 3:12:21 AM

Communication System: CDMA AWS; Frequency: 1752.5 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY4 Configuration:

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/11/2009

Phantom: HAC Test Arch; Type: SD HAC P01 BA;

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 22.0 V/m

Probe Modulation Factor = 1.00

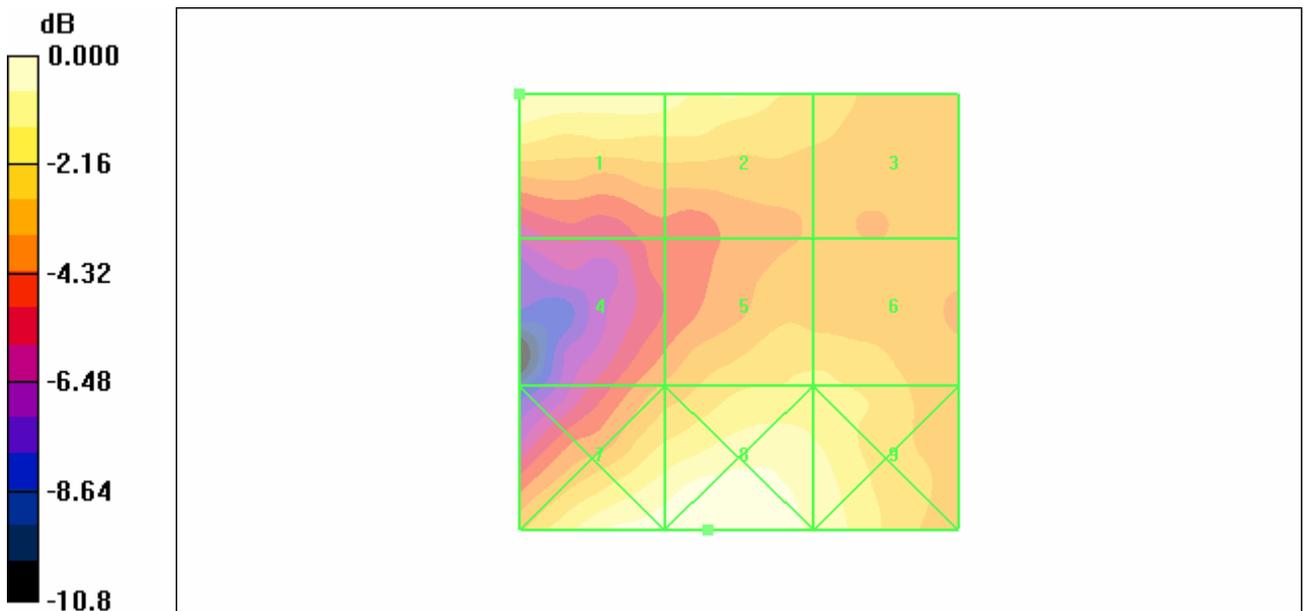
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 18.1 V/m; Power Drift = 0.041 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

| | | |
|--------------------------|--------------------------|--------------------------|
| Grid 1 22.0 M4 | Grid 2 21.3 M4 | Grid 3 18.2 M4 |
| Grid 4 16.0 M4 | Grid 5 18.8 M4 | Grid 6 18.8 M4 |
| Grid 7 23.0 M4 | Grid 8 23.8 M4 | Grid 9 21.7 M4 |



0 dB = 23.8V/m

Figure 24 HAC RF E-Field CDMA AWS Channel 850

TA Technology (Shanghai) Co., Ltd. Test Report

HAC RF E-Field CDMA AWS Middle

Date/Time: 6/22/2010 3:17:16 AM

Communication System: CDMA AWS; Frequency: 1732.5 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY4 Configuration:

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/11/2009

Phantom: HAC Test Arch; Type: SD HAC P01 BA;

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 24.4 V/m

Probe Modulation Factor = 1.00

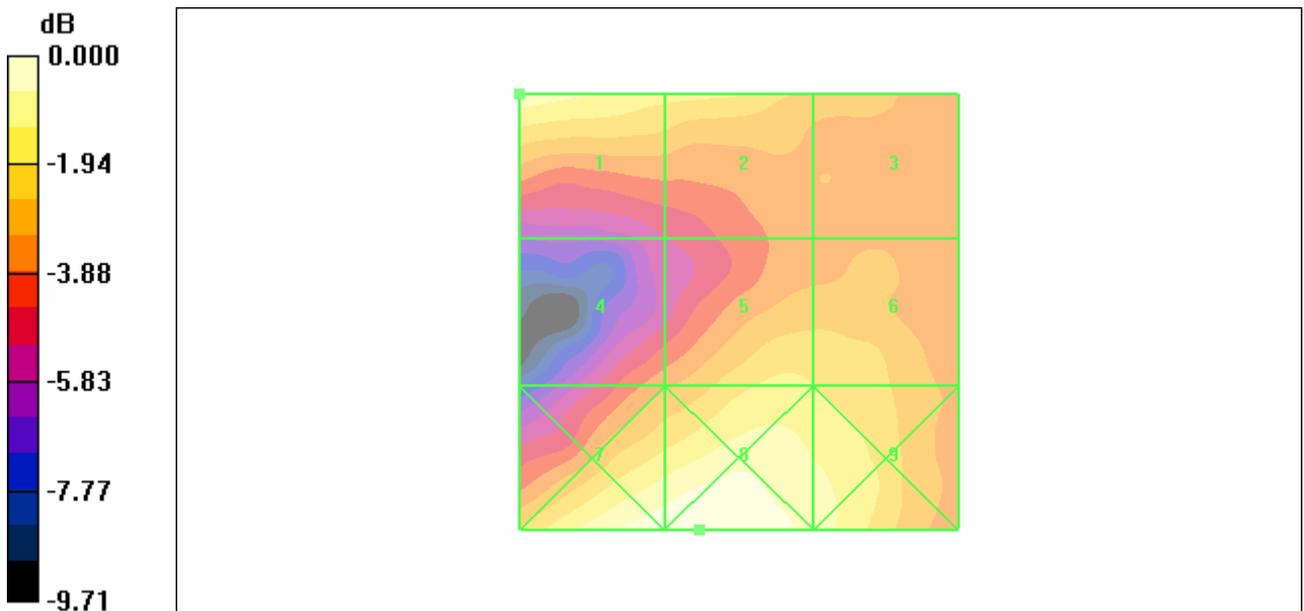
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 21.0 V/m; Power Drift = -0.005 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

| | | |
|--------------------------|--------------------------|--------------------------|
| Grid 1 24.4 M4 | Grid 2 22.1 M4 | Grid 3 19.9 M4 |
| Grid 4 18.2 M4 | Grid 5 22.0 M4 | Grid 6 21.5 M4 |
| Grid 7 26.4 M4 | Grid 8 26.9 M4 | Grid 9 24.3 M4 |



0 dB = 26.9V/m

Figure 25 HAC RF E-Field CDMA AWS Channel 450

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA2010-0916

Page 42 of 83

HAC RF E-Field CDMA AWS Low

Date/Time: 6/22/2010 3:22:03 AM

Communication System: CDMA AWS; Frequency: 1711.25 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY4 Configuration:

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/11/2009

Phantom: HAC Test Arch; Type: SD HAC P01 BA;

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan - ER3D: 15 mm from Probe Center to the Device /Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 25.5 V/m

Probe Modulation Factor = 1.00

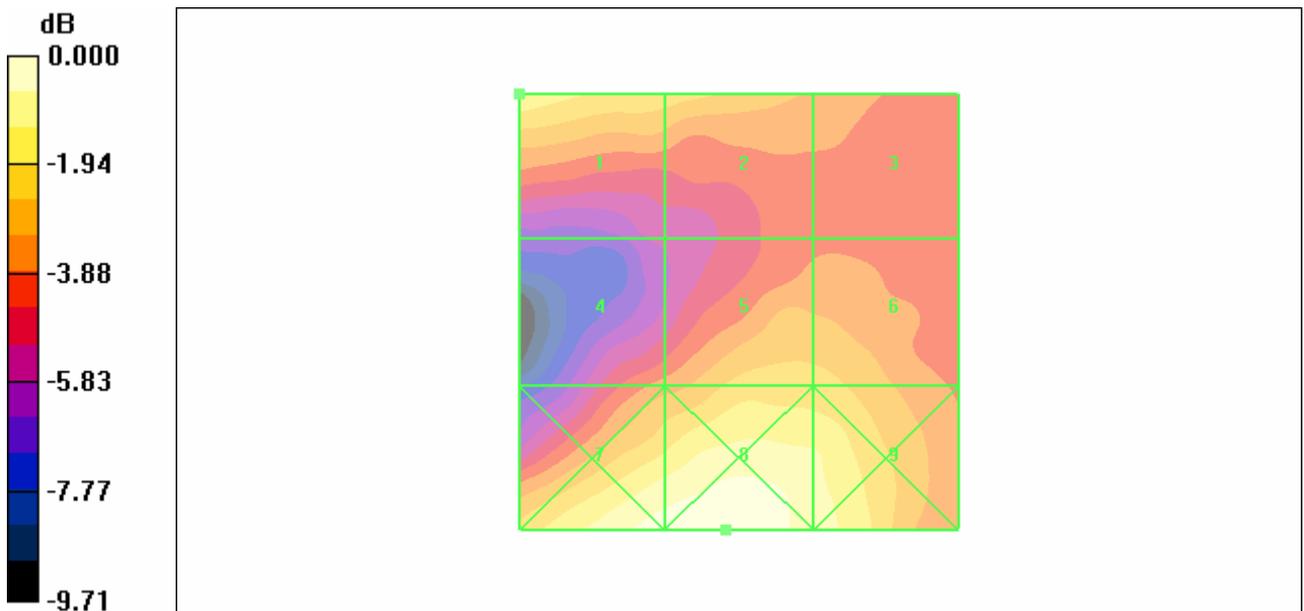
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 21.6 V/m; Power Drift = 0.061 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

| | | |
|--------------------------|--------------------------|--------------------------|
| Grid 1 25.5 M4 | Grid 2 23.4 M4 | Grid 3 20.4 M4 |
| Grid 4 19.8 M4 | Grid 5 23.0 M4 | Grid 6 22.9 M4 |
| Grid 7 28.8 M4 | Grid 8 29.8 M4 | Grid 9 26.8 M4 |



0 dB = 29.8V/m

Figure 26 HAC RF E-Field CDMA AWS Channel 25

TA Technology (Shanghai) Co., Ltd. Test Report

HAC RF H-Field CDMA AWS High

Date/Time: 6/22/2010 5:27:01 AM

Communication System: CDMA AWS; Frequency: 1752.5 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY4 Configuration:

Probe: H3DV6 - SN6260; Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/11/2009

Phantom: HAC Test Arch; Type: SD HAC P01 BA;

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan - H3DV6: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.063 A/m

Probe Modulation Factor = 1.00

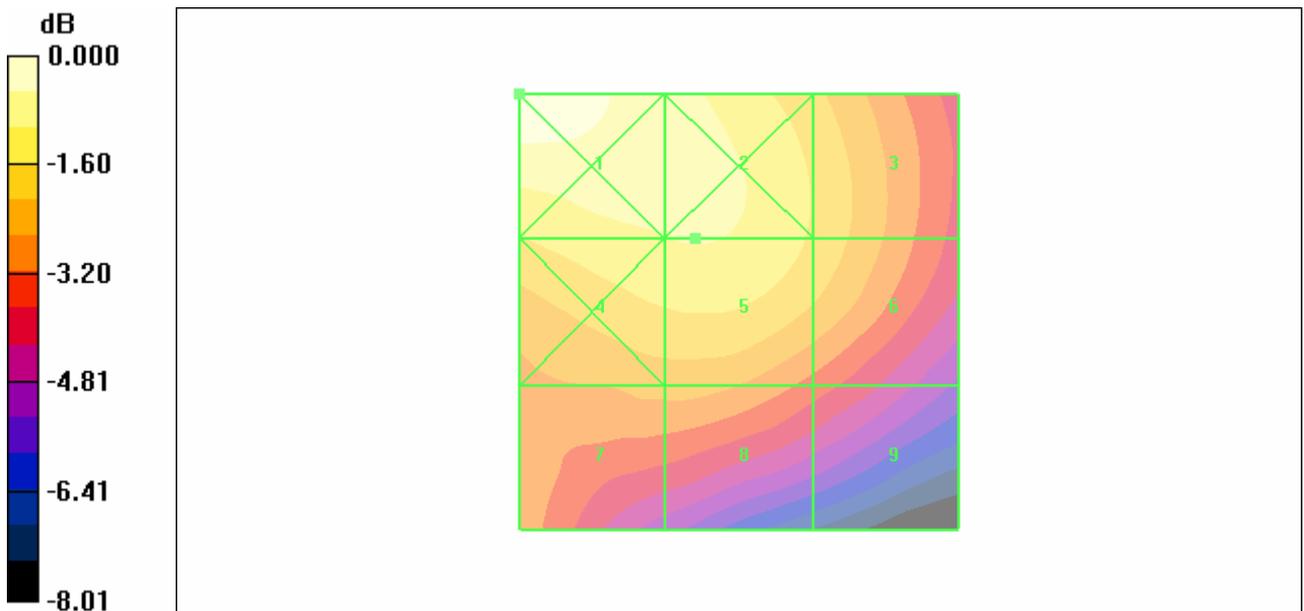
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.067 A/m; Power Drift = -0.009 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

| | | |
|-----------------|-----------------|-----------------|
| Grid 1 | Grid 2 | Grid 3 |
| 0.071 M4 | 0.065 M4 | 0.059 M4 |
| Grid 4 | Grid 5 | Grid 6 |
| 0.063 M4 | 0.063 M4 | 0.058 M4 |
| Grid 7 | Grid 8 | Grid 9 |
| 0.053 M4 | 0.054 M4 | 0.048 M4 |



0 dB = 0.071A/m

Figure 27 HAC RF H-Field CDMA AWS Channel 850

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA2010-0916

Page 44 of 83

HAC RF H-Field CDMA AWS Middle

Date/Time: 6/22/2010 5:22:13 AM

Communication System: CDMA AWS; Frequency: 1732.5 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY4 Configuration:

Probe: H3DV6 - SN6260; Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/11/2009

Phantom: HAC Test Arch; Type: SD HAC P01 BA;

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan - H3DV6: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.071 A/m

Probe Modulation Factor = 1.00

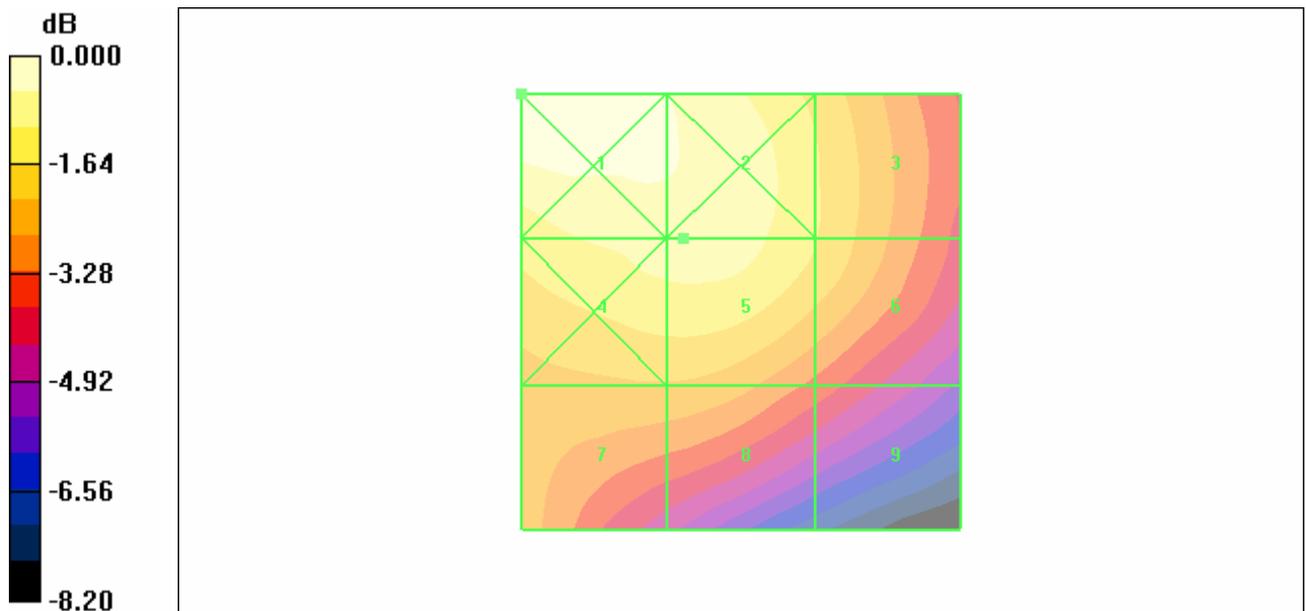
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.073 A/m; Power Drift = -0.012 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

| | | |
|---------------------------|---------------------------|---------------------------|
| Grid 1 0.078 M4 | Grid 2 0.074 M4 | Grid 3 0.065 M4 |
| Grid 4 0.071 M4 | Grid 5 0.071 M4 | Grid 6 0.065 M4 |
| Grid 7 0.060 M4 | Grid 8 0.060 M4 | Grid 9 0.052 M4 |



0 dB = 0.078A/m

Figure 28 HAC RF H-Field CDMA AWS Channel 450

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA2010-0916

Page 45 of 83

HAC RF H-Field CDMA AWS Low

Date/Time: 6/22/2010 4:47:08 AM

Communication System: CDMA AWS; Frequency: 1711.25 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY4 Configuration:

Probe: H3DV6 - SN6260; Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/11/2009

Phantom: HAC Test Arch; Type: SD HAC P01 BA;

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan - H3DV6: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.077 A/m

Probe Modulation Factor = 1.00

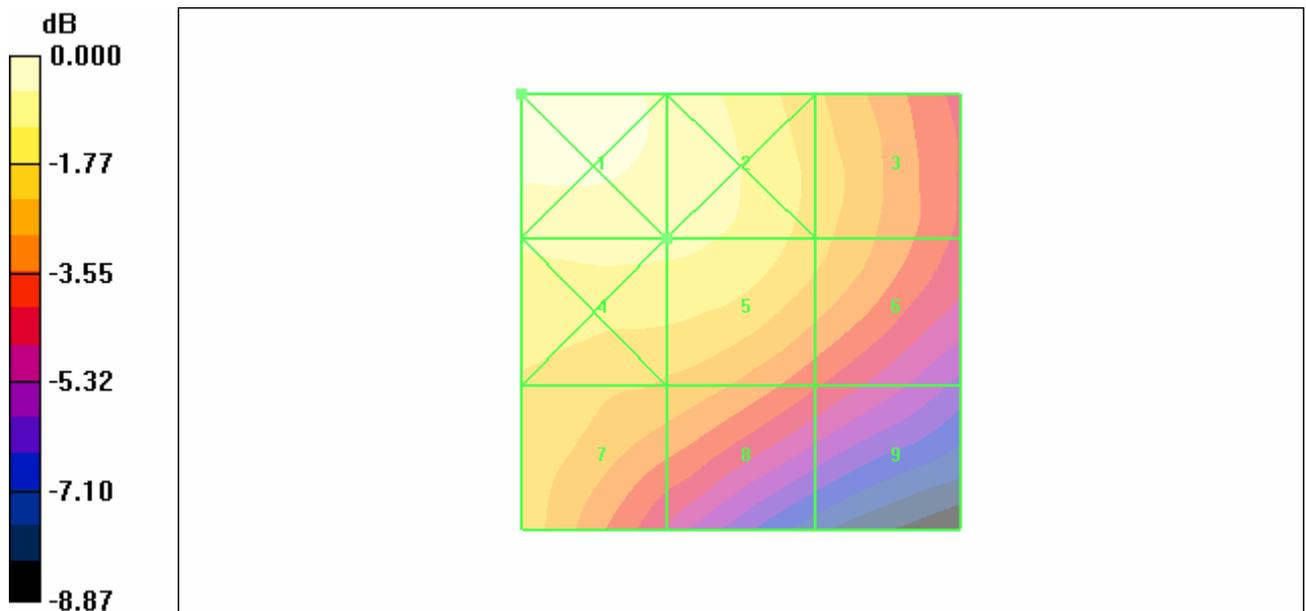
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.078 A/m; Power Drift = -0.132 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

| | | |
|---------------------------|---------------------------|---------------------------|
| Grid 1 0.087 M4 | Grid 2 0.080 M4 | Grid 3 0.070 M4 |
| Grid 4 0.078 M4 | Grid 5 0.077 M4 | Grid 6 0.068 M4 |
| Grid 7 0.071 M4 | Grid 8 0.066 M4 | Grid 9 0.055 M4 |



0 dB = 0.087A/m

Figure 29 HAC RF H-Field CDMA AWS Channel 25

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA2010-0916

Page 46 of 83

ANNEX C: E-Probe Calibration Certificate

**Calibration Laboratory of
Schmid & Partner
Engineering AG**
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **TMC**

Certificate No: **ER3-2428_Oct09**

CALIBRATION CERTIFICATE

Object: **ER3DV6 - SN:2428**

Calibration procedure(s): **QA CAL-02.v5 and QA CAL-25.v2
Calibration procedure for E-field probes optimized for close near field
evaluations in air**

Calibration date: **October 20, 2009**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

| Primary Standards | ID # | Cal Date (Certificate No.) | Scheduled Calibration |
|----------------------------|-----------------|-----------------------------------|------------------------|
| Power meter E4419B | GB41293874 | 1-Apr-09 (No. 217-01030) | Apr-10 |
| Power sensor E4412A | MY41495277 | 1-Apr-09 (No. 217-01030) | Apr-10 |
| Power sensor E4412A | MY41498087 | 1-Apr-09 (No. 217-01030) | Apr-10 |
| Reference 3 dB Attenuator | SN: S5054 (3c) | 31-Mar-09 (No. 217-01026) | Mar-10 |
| Reference 20 dB Attenuator | SN: S5086 (20b) | 31-Mar-09 (No. 217-01028) | Mar-10 |
| Reference 30 dB Attenuator | SN: S5129 (30b) | 31-Mar-09 (No. 217-01027) | Mar-10 |
| Reference Probe ER3DV6 | SN: 2328 | 3-Oct-09 (No. ER3-2328_Oct09) | Oct-10 |
| DAE4 | SN: 789 | 19-Dec-08 (No. DAE4-789_Dec08) | Dec-09 |
| Secondary Standards | ID # | Check Date (in house) | Scheduled Check |
| RF generator HP 8648C | US3642U01700 | 4-Aug-99 (in house check Oct-09) | In house check: Oct-11 |
| Network Analyzer HP 8753E | US37390585 | 18-Oct-01 (in house check Oct-09) | In house check: Oct10 |

| | | | |
|----------------|------------------------------|--|---------------|
| Calibrated by: | Name Marcel Fehr | Function Laboratory Technician | Signature |
| Approved by: | Name Katja Pokovic | Function Technical Manager | Signature |

Issued: October 22, 2009

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA2010-0916

Page 47 of 83

**Calibration Laboratory of
Schmid & Partner
Engineering AG**
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Glossary:

| | |
|--------------------------|---|
| NORM _{x,y,z} | sensitivity in free space |
| DCP | diode compression point |
| CF | crest factor (1/duty_cycle) of the RF signal |
| A, B, C | modulation dependent linearization parameters |
| Polarization φ | φ rotation around probe axis |
| Polarization ϑ | ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis |
| Connector Angle | information used in DASY system to align probe sensor X to the robot coordinate system |

Calibration is Performed According to the Following Standards:

- IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005.

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}**: Assessed for E-field polarization $\vartheta = 0$ for XY sensors and $\vartheta = 90$ for Z sensor ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide).
- NORM(f)_{x,y,z}** = NORM_{x,y,z} * frequency_response (see Frequency Response Chart).
- DCP_{x,y,z}**: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- A_{x,y,z}; B_{x,y,z}; C_{x,y,z}** are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media.
- Spherical isotropy (3D deviation from isotropy)**: in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle**: The angle is assessed using the information gained by determining the NORM_x (no uncertainty required).

ER3DV6 SN:2428

October 20, 2009

Probe ER3DV6

SN:2428

| | |
|------------------|--------------------|
| Manufactured: | September 11, 2007 |
| Last calibrated: | December 13, 2007 |
| Recalibrated: | October 20, 2009 |

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

TA Technology (Shanghai) Co., Ltd.
Test Report

ER3DV6 SN:2428

October 20, 2009

DASY - Parameters of Probe: ER3DV6 SN:2428

Basic Calibration Parameters

| | Sensor X | Sensor Y | Sensor Z | Unc (k=2) |
|--|----------|----------|----------|--------------|
| Norm ($\mu\text{V}/(\text{V}/\text{m})^2$) | 1.52 | 1.59 | 1.86 | $\pm 10.1\%$ |
| DCP (mV) ^A | 91.5 | 93.0 | 98.9 | |

Modulation Calibration Parameters

| UID | Communication System Name | PAR | | A dB | B dBuV | C | VR mV | Unc (k=2) |
|-------|---------------------------|-----|---|---------|-----------|------|----------|--------------|
| 10000 | CW | | X | 0.00 | 0.00 | 1.00 | 300 | $\pm 1.5\%$ |
| | | | Y | 0.00 | 0.00 | 1.00 | 300 | |
| | | | Z | 0.00 | 0.00 | 1.00 | 300 | |

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

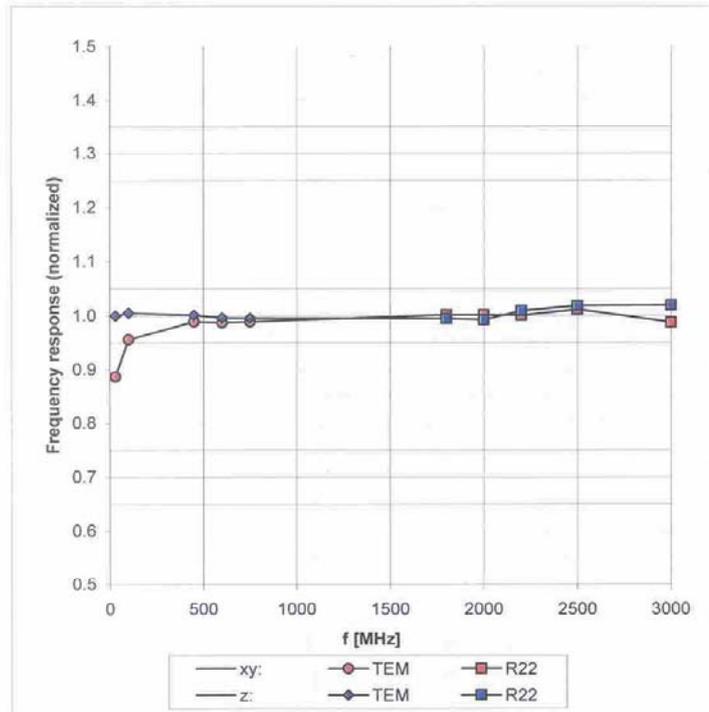
^A numerical linearization parameter: uncertainty not required

ER3DV6 SN:2428

October 20, 2009

Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide R22)

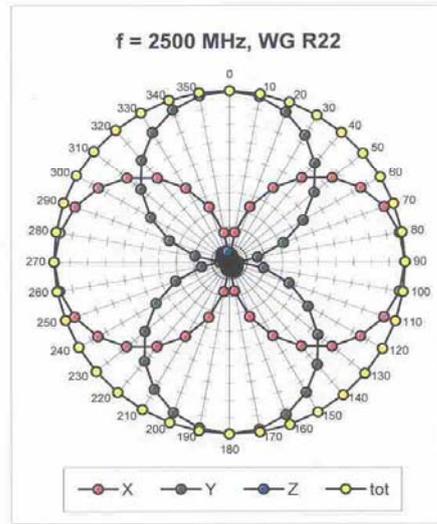
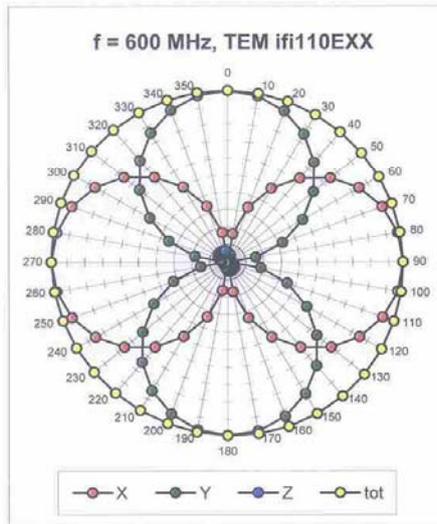


Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ (k=2)

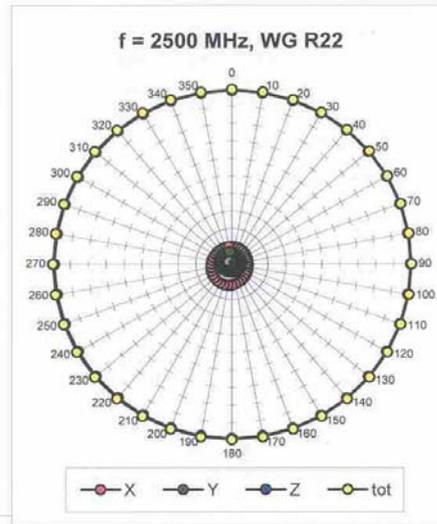
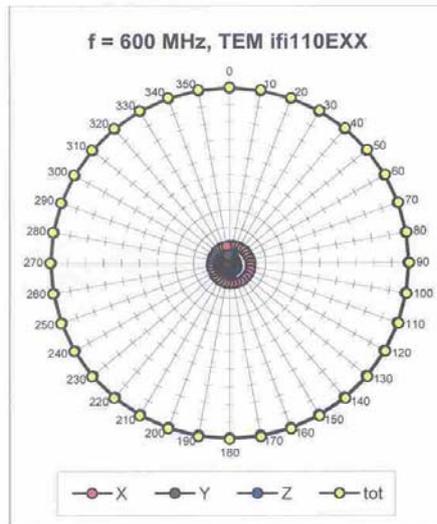
ER3DV6 SN:2428

October 20, 2009

Receiving Pattern (ϕ), $\vartheta = 0^\circ$



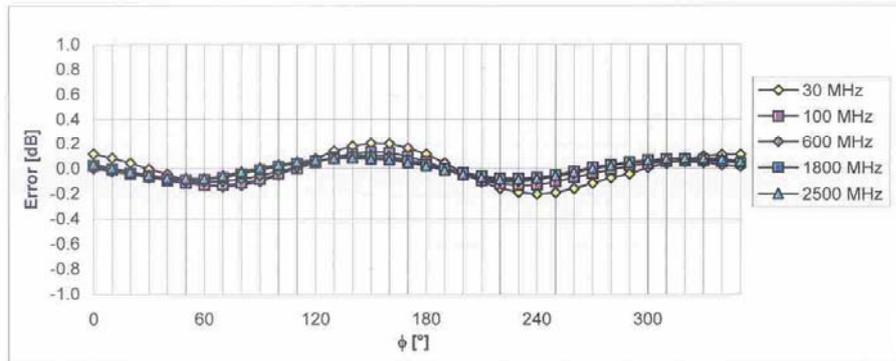
Receiving Pattern (ϕ), $\vartheta = 90^\circ$



ER3DV6 SN:2428

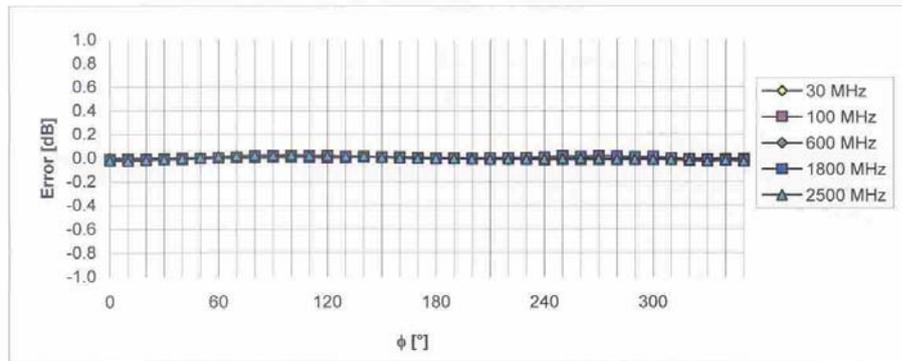
October 20, 2009

Receiving Pattern (ϕ), $\vartheta = 0^\circ$



Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

Receiving Pattern (ϕ), $\vartheta = 90^\circ$

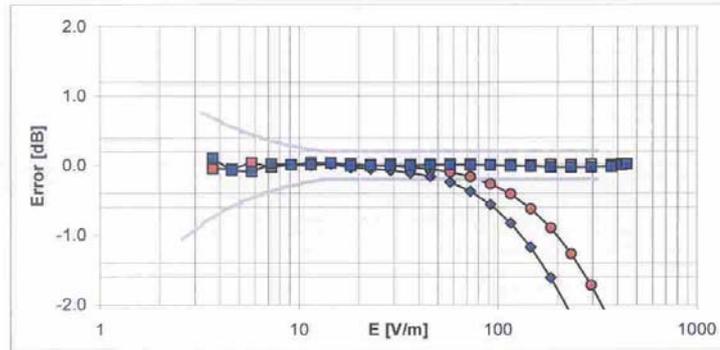
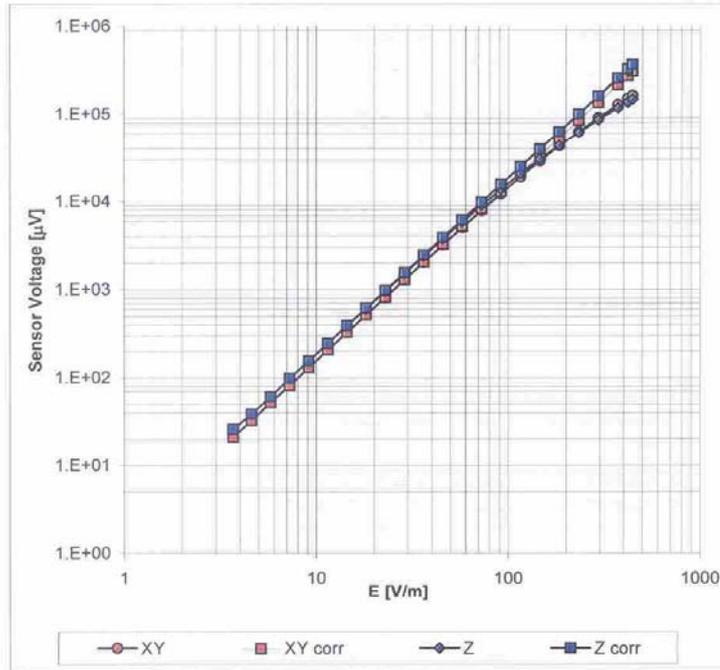


Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

ER3DV6 SN:2428

October 20, 2009

Dynamic Range f(E-field)
(Waveguide R22, f = 1800 MHz)

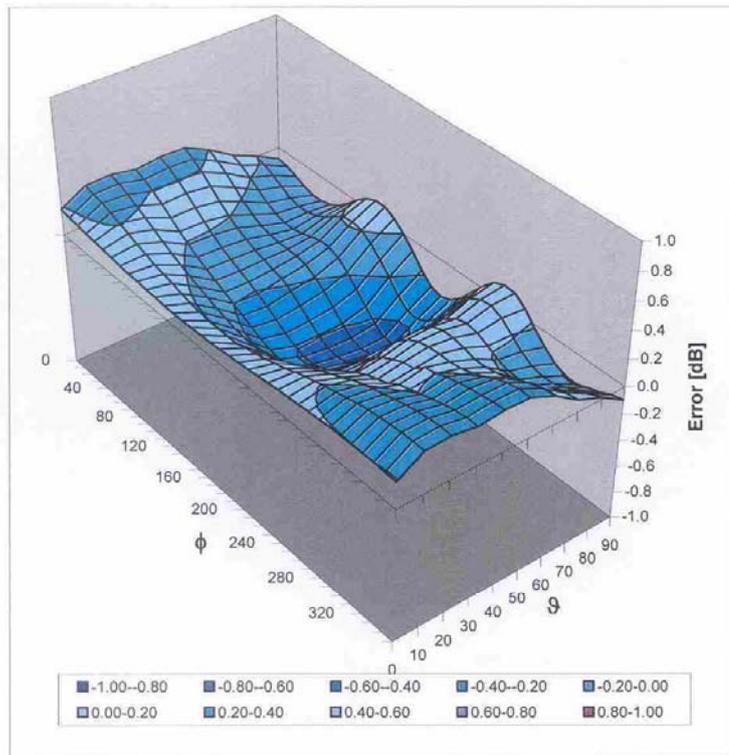


Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)

ER3DV6 SN:2428

October 20, 2009

Deviation from Isotropy in Air
Error (ϕ, ϑ), $f = 900$ MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ ($k=2$)

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA2010-0916

Page 55 of 83

ER3DV6 SN:2428

October 20, 2009

Other Probe Parameters

| | |
|---|-------------|
| Sensor Arrangement | Rectangular |
| Connector Angle (°) | -218.7 |
| Mechanical Surface Detection Mode | enabled |
| Optical Surface Detection Mode | disabled |
| Probe Overall Length | 337 mm |
| Probe Body Diameter | 10 mm |
| Tip Length | 10 mm |
| Tip Diameter | 8.0 mm |
| Probe Tip to Sensor X Calibration Point | 2.5 mm |
| Probe Tip to Sensor Y Calibration Point | 2.5 mm |
| Probe Tip to Sensor Z Calibration Point | 2.5 mm |

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA2010-0916

Page 56 of 83

ANNEX D: H-Probe Calibration Certificate

**Calibration Laboratory of
Schmid & Partner
Engineering AG**
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **TMC**

Certificate No: **H3-6260_Oct09**

CALIBRATION CERTIFICATE

Object: **H3DV6 - SN:6260**

Calibration procedure(s): **QA CAL-03.v5 and QA CAL-25.v2
Calibration procedure for H-field probes optimized for close near field
evaluations in air**

Calibration date: **October 20, 2009**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

| Primary Standards | ID # | Cal Date (Certificate No.) | Scheduled Calibration |
|----------------------------|-----------------|-----------------------------------|------------------------|
| Power meter E4419B | GB41293874 | 1-Apr-09 (No. 217-01030) | Apr-10 |
| Power sensor E4412A | MY41495277 | 1-Apr-09 (No. 217-01030) | Apr-10 |
| Power sensor E4412A | MY41498087 | 1-Apr-09 (No. 217-01030) | Apr-10 |
| Reference 3 dB Attenuator | SN: S5054 (3c) | 31-Mar-09 (No. 217-01026) | Mar-10 |
| Reference 20 dB Attenuator | SN: S5086 (20b) | 31-Mar-09 (No. 217-01028) | Mar-10 |
| Reference 30 dB Attenuator | SN: S5129 (30b) | 31-Mar-09 (No. 217-01027) | Mar-10 |
| Reference Probe H3DV6 | SN: 6182 | 3-Oct-09 (No. H3-6182_Oct09) | Oct-10 |
| DAE4 | SN: 789 | 19-Dec-08 (No. DAE4-789_Dec08) | Dec-09 |
| Secondary Standards | ID # | Check Date (in house) | Scheduled Check |
| RF generator HP 8648C | US3642U01700 | 4-Aug-99 (in house check Oct-09) | In house check: Oct-11 |
| Network Analyzer HP 8753E | US37390585 | 18-Oct-01 (in house check Oct-09) | In house check: Oct10 |

| Calibrated by: | Name | Function | Signature |
|----------------|---------------|-----------------------|-----------|
| | Marcel Fehr | Laboratory Technician | |
| Approved by: | Katja Pokovic | Technical Manager | |

Issued: October 22, 2009

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA2010-0916

Page 57 of 83

**Calibration Laboratory of
Schmid & Partner
Engineering AG**
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
S Service suisse d'étalonnage
C Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Glossary:

| | |
|--------------------------|---|
| NORM _{x,y,z} | sensitivity in free space |
| DCP | diode compression point |
| CF | crest factor (1/duty_cycle) of the RF signal |
| A, B, C | modulation dependent linearization parameters |
| Polarization φ | φ rotation around probe axis |
| Polarization ϑ | ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis |
| Connector Angle | information used in DASY system to align probe sensor X to the robot coordinate system |

Calibration is Performed According to the Following Standards:

- IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005.

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}*: Assessed for E-field polarization $\vartheta = 0$ for XY sensors and $\vartheta = 90$ for Z sensor ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide).
- X, Y, Z(f)_a0a1a2 = X, Y, Z_a0a1a2* frequency_response* (see Frequency Response Chart).
- DCP_{x,y,z}*: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- A_{x,y,z}; B_{x,y,z}; C_{x,y,z}* are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media.
- Spherical isotropy (3D deviation from isotropy)*: in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset*: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle*: The angle is assessed using the information gained by determining the *X_a0a1a2* (no uncertainty required).

H3DV6 SN:6260

October 20, 2009

Probe H3DV6

SN:6260

| | |
|------------------|-------------------|
| Manufactured: | September 7, 2007 |
| Last calibrated: | December 13, 2007 |
| Recalibrated: | October 20, 2009 |

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA2010-0916

Page 59 of 83

H3DV6 SN:6260

October 20, 2009

DASY - Parameters of Probe: H3DV6 SN:6260

Basic Calibration Parameters

| | | Sensor X | Sensor Y | Sensor Z | Unc (k=2) |
|--------------------------------|----|----------|----------|----------|--------------|
| Norm (A/m / $\sqrt{(\mu V)}$) | a0 | 2.47E-3 | 2.49E-3 | 2.95E-3 | $\pm 10.1\%$ |
| Norm (A/m / $\sqrt{(\mu V)}$) | a1 | -2.97E-5 | 5.62E-6 | -4.47E-5 | $\pm 10.1\%$ |
| Norm (A/m / $\sqrt{(\mu V)}$) | a2 | 4.84E-5 | 4.36E-5 | 6.01E-5 | $\pm 10.1\%$ |
| DCP (mV) ^A | | 84.5 | 90.3 | 83.9 | |

Modulation Calibration Parameters

| UID | Communication System Name | PAR | | A dB | B dBuV | C | VR mV | Unc (k=2) |
|-------|---------------------------|------|---|---------|-----------|------|----------|--------------|
| 10000 | CW | 0.00 | X | 0.00 | 0.00 | 1.00 | 300 | $\pm 1.5\%$ |
| | | | Y | 0.00 | 0.00 | 1.00 | 300 | |
| | | | Z | 0.00 | 0.00 | 1.00 | 300 | |

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

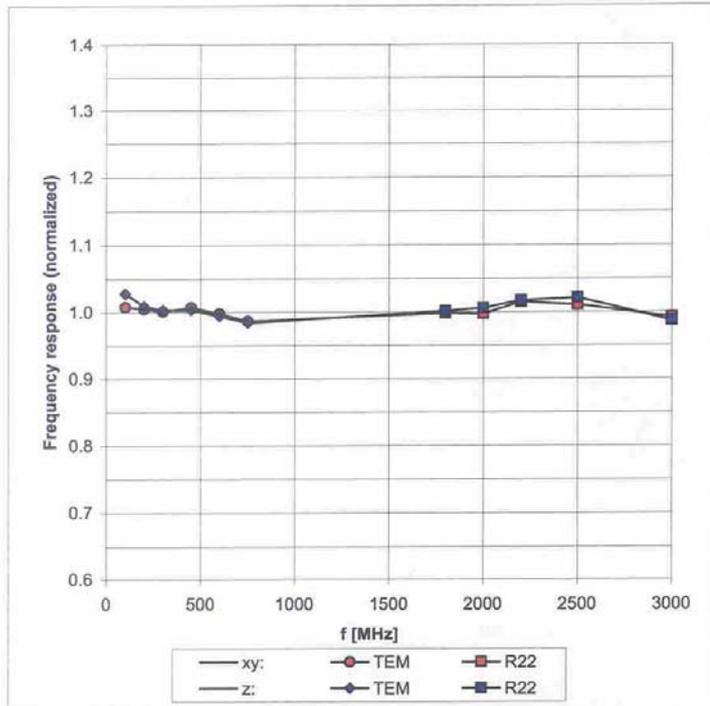
¹ numerical linearization parameter: uncertainty not required

H3DV6 SN:6260

October 20, 2009

Frequency Response of H-Field

(TEM-Cell:ifi110 EXX, Waveguide R22)



Uncertainty of Frequency Response of H-field: $\pm 6.3\%$ (k=2)